Low-Power, 16-Bit, Sampling CMOS ANALOG-to-DIGITAL CONVERTER

FEATURES

- **35mW max POWER DISSIPATION**
- **50μW POWER-DOWN MODE**
- **25μs max ACQUISITION AND CONVERSION**
- **$\pm$1.5LSB max INL**
- **DNL: 16 bits "No Missing Codes"**
- **86dB min SINAD WITH 1kHz INPUT**
- **$\pm$10V, 0V TO +5V, AND 0V TO +4V INPUT RANGES**
- **SINGLE +5V SUPPLY OPERATION**
- **PARALLEL AND SERIAL DATA OUTPUT**
- **PIN-COMPATIBLE WITH THE 12-BIT ADS7806**
- **USES INTERNAL OR EXTERNAL REFERENCE**
- **0.3" DIP-28 AND SO-28**

DESCRIPTION

The ADS7807 is a low-power, 16-bit, sampling Analog-to-Digital (A/D) converter using state-of-the-art CMOS structures. It contains a complete 16-bit, capacitor-based, Successive Approximation Register (SAR) A/D converter with sample-and-hold, clock, reference, and microprocessor interface with parallel and serial output drivers.

The ADS7807 can acquire and convert 16-bits to within $\pm$1.5LSB in 25μs max while consuming only 35mW max. Laser trimmed scaling resistors provide standard industrial input ranges of $\pm$10V and 0V to +5V. In addition, a 0V to +4V range allows development of complete single-supply systems.

The ADS7807 is available in a 0.3" DIP-28 and SO-28, both fully specified for operation over the industrial −40°C to +85°C temperature range.

ABSOLUTE MAXIMUM RATINGS[1]

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Analog Inputs: R1_IN ............................................................. ±12V
              R2_IN ............................................................. ±5.5V
              CAP .................................. V_ANA + 0.3V to AGND2 − 0.3V
              REF ........................................ Indefinite Short to AGND2,
                                                        Momentary Short to V_ANA
Ground Voltage Differences: DGND, AGND1, and AGND2 ............. ±0.3V
V_ANA ............................................................................ 7V
V_DIG to V_ANA ............................................................. +0.3V
V_DIG ............................................................................ 7V
Digital Inputs ........................................... −0.3V to V_DIG + 0.3V
Maximum Junction Temperature .................................... +165°C
Internal Power Dissipation ........................................... 825mW
Lead Temperature (soldering, 10s) ............................... +300°C
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NOTE: (1) Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.

⚠ ELECTROSTATIC DISCHARGE SENSITIVITY

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PACKAGE/ORDERING INFORMATION

PRODUCT	MAXIMUM INTEGRAL LINEARITY ERROR (LSB)	SPECIFIED NO MISSING CODE LEVEL (LSB)	MINIMUM SIGNAL-TO-(NOISE + DISTORTION) RATIO (DB)	PACKAGE-LEAD	PACKAGE DESIGNATOR[1]	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
ADS7807P	±3	15	83	Dip-28	NT	−40°C to +85°C	ADS7807P	ADS7807P	Tubes, 13
ADS7807PB	±1.5	16	86	"	"	"	ADS7807PB	ADS7807PB	Tubes, 13
ADS7807U	±3	15	83	SO-28	DW	−40°C to +85°C	ADS7807U	ADS7807U	Tubes, 28
"	"	"	"	"	"	"	"	ADS7807U/1K	Tape and Reel, 1000
ADS7807UB	±1.5	16	86	"	"	"	ADS7807UB	ADS7807UB	Tubes, 28
"	"	"	"	"	"	"	"	ADS7807UB/1K	Tape and Reel, 1000

NOTE: (1) For the most current specifications and package information, refer to our web site at www.ti.com.

ELECTRICAL CHARACTERISTICS

At T_A = −40°C to +85°C, f_S = 40kHz, V_{DIG} = V_{ANA} = +5V, and using internal reference and fixed resistors (see Figure 7b), unless otherwise specified.

PARAMETER	CONDITIONS	ADS7807P, U MIN	ADS7807P, U TYP	ADS7807P, U MAX	ADS7807PB, UB MIN	ADS7807PB, UB TYP	ADS7807PB, UB MAX	UNITS
RESOLUTION				16			*	Bits
ANALOG INPUT								
Voltage Ranges				±10, 0 to +5, 0 to +4				V
Impedance				(See Table II)				
Capacitance			35			*		pF
THROUGHPUT SPEED								
Conversion Time				20			*	µs
Complete Cycle	Acquire and Convert			25			*	µs
Throughput Rate		40			*			kHz
DC ACCURACY								
Integral Linearity Error				±3			±1.5	LSB[1]
Differential Linearity Error				+3, −2			+1.5, −1	LSB
No Missing Codes		15			16			Bits
Transition Noise[2]			0.8			*		LSB
Gain Error			±0.2			±0.1		%
Full-Scale Error[3,4]				±0.5			±0.25	%
Full-Scale Error Drift			±7			±5		ppm/°C
Full-Scale Error[3,4]	Ext. 2.5000V Ref			±0.5			±0.25	%
Full-Scale Error Drift	Ext. 2.5000V Ref		±0.5			*		ppm/°C
Bipolar Zero Error[3]	±10V Range			±10			*	mV
Bipolar Zero Error Drift	±10V Range		±0.5			*		ppm/°C
Unipolar Zero Error[3]	0V to 5V, 0V to 4V Ranges			±3			*	mV
Unipolar Zero Error Drift	0V to 5V, 0V to 4V Ranges		±0.5			*		ppm/°C
Recovery Time to Rated Accuracy from Power-Down[5]	2.2µF Capacitor to CAP		1			*		ms
Power-Supply Sensitivity (V_{DIG} = V_{ANA} = V_S)	+4.75V < V_S < +5.25V			±8			*	LSB

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ELECTRICAL CHARACTERISTICS (Cont.)

At T_A = –40°C to +85°C, f_S = 40kHz, V_{DIG} = V_{ANA} = +5V, and using internal reference and fixed resistors (see Figure 7b), unless otherwise specified.

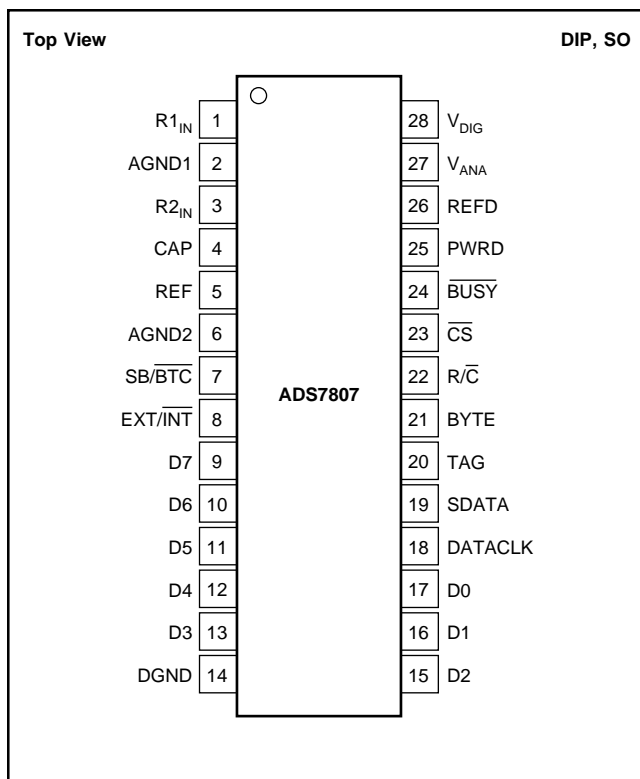| PARAMETER	CONDITIONS	ADS7807P, U			ADS7807PB, UB			UNITS
		MIN	TYP	MAX	MIN	TYP	MAX	
AC ACCURACY								
Spurious-Free Dynamic Range	f_{IN} = 1kHz, ±10V	90	100		96	∗		dB[6]
Total Harmonic Distortion	f_{IN} = 1kHz, ±10V		–100	–90		∗	–96	dB
Signal-to-(Noise + Distortion)	f_{IN} = 1kHz, ±10V	83	88		86	∗		dB
	–60dB Input		30			32		dB
Signal-to-Noise	f_{IN} = 1kHz, ±10V	83	88		86	∗		dB
Usable Bandwidth[7]			130			∗		kHz
Full-Power Bandwidth (–3dB)			600			∗		kHz
SAMPLING DYNAMICS								
Aperture Delay			40			∗		ns
Aperture Jitter			20			∗		ps
Transient Response	FS Step			5			∗	µs
Over-Voltage Recovery[8]			750			∗		ns
REFERENCE								
Internal Reference Voltage	No Load	2.48	2.5	2.52	∗	∗	∗	V
Internal Reference Source Current			1			∗		µA
(Must use external buffer.)								
Internal Reference Drift			8			∗		ppm/°C
External Reference Voltage Range		2.3	2.5	2.7	∗	∗	∗	V
for Specified Linearity								
External Reference Current Drain	External 2.5000V Ref		100				∗	µA
DIGITAL INPUTS								
Logic Levels								
V_{IL}		–0.3		+0.8	∗		∗	V
V_{IH}[9]		+2.0		V_D + 0.3V	∗		∗	V
I_{IL}	V_{IL} = 0V			±10			∗	µA
I_{IH}	V_{IH} = 5V			±10			∗	µA
DIGITAL OUTPUTS								
Data Format		Parallel 16 bits in 2-bytes; Serial						
Data Coding		Binary Two's Complement or Straight Binary						
V_{OL}	I_{SINK} = 1.6mA			+0.4			∗	V
V_{OH}	I_{SOURCE} = 500µA	+4			∗			V
Leakage Current	High-Z State,			±5			∗	µA
	V_{OUT} = 0V to V_{DIG}							
Output Capacitance	High-Z State			15			∗	pF
DIGITAL TIMING								
Bus Access Time	R_L = 3.3kΩ, C_L = 50pF			83			∗	ns
Bus Relinquish Time	R_L = 3.3kΩ, C_L = 10pF			83			∗	ns
POWER SUPPLIES								
Specified Performance								
V_{DIG}	Must be ≤ V_{ANA}	+4.75	+5	+5.25	∗	∗	∗	V
V_{ANA}		+4.75	+5	+5.25	∗	∗	∗	V
I_{DIG}			0.6			∗		mA
I_{ANA}			5.0			∗		mA
Power Dissipation	V_{ANA} = V_{DIG} = 5V, f_S = 40kHz		28	35		∗	∗	mW
	REFD HIGH		23			∗		mW
	PWRD and REFD HIGH		50			∗		µW
TEMPERATURE RANGE								
Specified Performance		–40		+85	∗		∗	°C
Derated Performance		–55		+125	∗		∗	°C
Storage		–65		+150	∗		∗	°C
Thermal Resistance (θ_{JA})								
DIP			75			∗		°C/W
SO			75			∗		°C/W

∗ Same specifications as ADS7807P, U.

NOTES: (1) LSB means Least Significant Bit. One LSB for the ±10V input range is 305µV. (2) Typical rms noise at worst-case transition. (3) As measured with fixed resistors, see Figure 7b. Adjustable to zero with external potentiometer. (4) Full-scale error is the worst case of –Full-Scale or +Full-Scale untrimmed deviation from ideal first and last code transitions, divided by the transition voltage (not divided by the full-scale range) and includes the effect of offset error. (5) This is the time delay after the ADS7807 is brought out of Power-Down mode until all internal settling occurs and the analog input is acquired to rated accuracy. A Convert command after this delay will yield accurate results. (6) All specifications in dB are referred to a full-scale input. (7) Usable bandwidth defined as full-scale input frequency at which Signal-to-(Noise + Distortion) degrades to 60dB. (8) Recovers to specified performance after 2 • FS input overvoltage. (9) The minimum V_{IH} level for the DATACLK signal is 3V.

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PIN DESCRIPTIONS

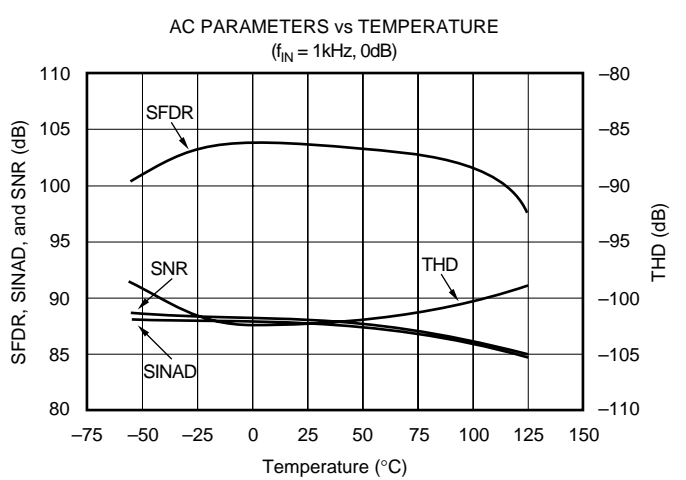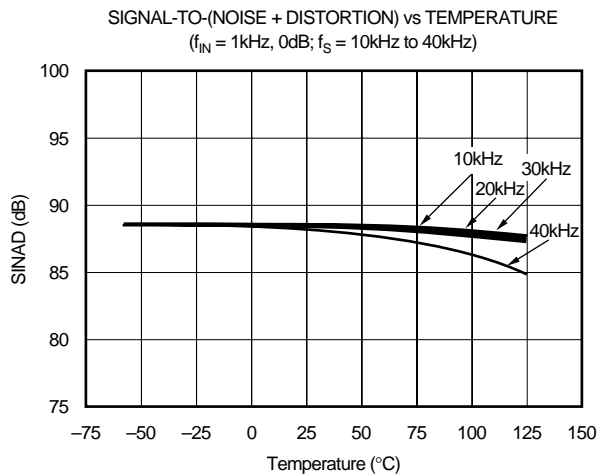| PIN #	NAME	DIGITAL I/O	DESCRIPTION
1	R1$_{IN}$		Analog Input. See Figure 7.
2	AGND1		Analog Sense Ground.
3	R2$_{IN}$		Analog Input. See Figure 7.
4	CAP		Reference Buffer Output. 2.2µF tantalum capacitor to ground.
5	REF		Reference Input/Output. 2.2µF tantalum capacitor to ground.
6	AGND2		Analog Ground
7	SB/$\overline{BTC}$	I	Selects Straight Binary or Binary Two's Complement for Output Data Format.
8	EXT/$\overline{INT}$	I	External/Internal data clock select.
9	D7	O	Data Bit 7 if BYTE is HIGH. Data bit 15 (MSB) if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW. Leave unconnected when using serial output.
10	D6	O	Data Bit 6 if BYTE is HIGH. Data bit 14 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
11	D5	O	Data Bit 5 if BYTE is HIGH. Data bit 13 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
12	D4	O	Data Bit 4 if BYTE is HIGH. Data bit 12 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
13	D3	O	Data Bit 3 if BYTE is HIGH. Data bit 11 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
14	DGND		Digital Ground
15	D2	O	Data Bit 2 if BYTE is HIGH. Data bit 10 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
16	D1	O	Data Bit 1 if BYTE is HIGH. Data bit 9 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
17	D0	O	Data Bit 0 (LSB) if BYTE is HIGH. Data bit 8 if BYTE is LOW. Hi-Z when $\overline{CS}$ is HIGH and/or R/$\overline{C}$ is LOW.
18	DATACLK	I/O	Data Clock Output when EXT/$\overline{INT}$ is LOW. Data clock input when EXT/$\overline{INT}$ is HIGH.
19	SDATA	O	Serial Output Synchronized to DATACLK
20	TAG	I	Serial Input When Using an External Data Clock
21	BYTE	I	Selects 8 most significant bits (LOW) or 8 least significant bits (HIGH) on parallel output pins.
22	R/$\overline{C}$	I	With $\overline{CS}$ LOW and $\overline{BUSY}$ HIGH, a Falling Edge on R/$\overline{C}$ Initiates a New Conversion. With $\overline{CS}$ LOW, a rising edge on R/$\overline{C}$ enables the parallel output.
23	$\overline{CS}$	I	Internally OR'd with R/$\overline{C}$. If R/$\overline{C}$ is LOW, a falling edge on $\overline{CS}$ initiates a new conversion. If EXT/$\overline{INT}$ is LOW, this same falling edge will start the transmission of serial data results from the previous conversion.
24	$\overline{BUSY}$	O	At the start of a conversion, $\overline{BUSY}$ goes LOW and stays LOW until the conversion is completed and the digital outputs have been updated.
25	PWRD	I	PWRD HIGH shuts down all analog circuitry except the reference. Digital circuitry remains active.
26	REFD	I	REFD HIGH shuts down the internal reference. External reference will be required for conversions.
27	V$_{ANA}$		Analog Supply. Nominally +5V. Decouple with 0.1µF ceramic and 10µF tantalum capacitors.
28	V$_{DIG}$		Digital Supply. Nominally +5V. Connect directly to pin 27. Must be ≤ V$_{ANA}$.

PIN CONFIGURATION

Top View   DIP, SO

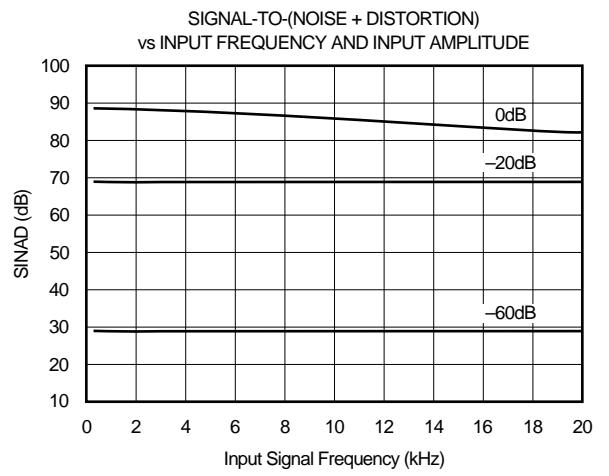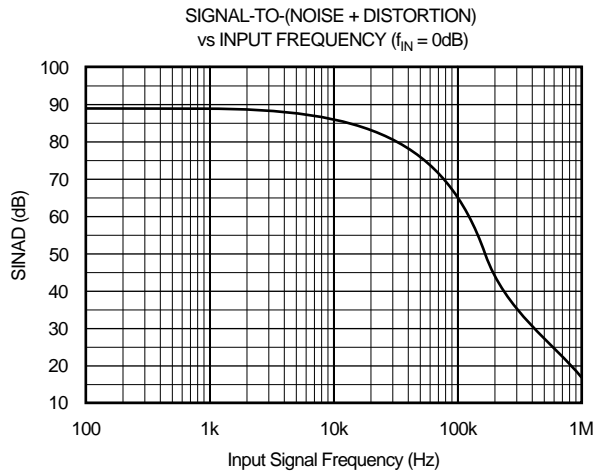|	ADS7807	
R1$_{IN}$	1	28 V$_{DIG}$
AGND1	2	27 V$_{ANA}$
R2$_{IN}$	3	26 REFD
CAP	4	25 PWRD
REF	5	24 $\overline{BUSY}$
AGND2	6	23 $\overline{CS}$
SB/$\overline{BTC}$	7	22 R/$\overline{C}$
EXT/$\overline{INT}$	8	21 BYTE
D7	9	20 TAG
D6	10	19 SDATA
D5	11	18 DATACLK
D4	12	17 D0
D3	13	16 D1
DGND	14	15 D2

ANALOG INPUT RANGE	CONNECT R1$_{IN}$ VIA 200Ω TO	CONNECT R2$_{IN}$ VIA 100Ω TO	IMPEDANCE
±10V	V$_{IN}$	CAP	45.7kΩ
0V to 5V	AGND	V$_{IN}$	20.0kΩ
0V to 4V	V$_{IN}$	V$_{IN}$	21.4kΩ

TABLE I. Input Range Connections. See Figure 7.

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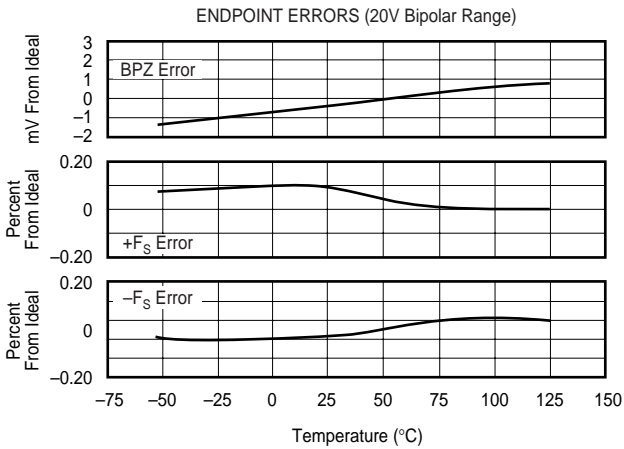# TYPICAL CHARACTERISTICS

At T_A = +25°C, f_S = 40kHz, V_{DIG} = V_{ANA} = +5V, and using internal reference and fixed resistors (see Figure 7b), unless otherwise specified.

FREQUENCY SPECTRUM
(8192 Point FFT; f_{IN} = 1kHz, 0dB)

FREQUENCY SPECTRUM
(8192 Point FFT; f_{IN} = 15kHz, 0dB)

SIGNAL-TO-(NOISE + DISTORTION)
vs INPUT FREQUENCY (f_{IN} = 0dB)

SIGNAL-TO-(NOISE + DISTORTION)
vs INPUT FREQUENCY AND INPUT AMPLITUDE

SIGNAL-TO-(NOISE + DISTORTION) vs TEMPERATURE
(f_{IN} = 1kHz, 0dB; f_S = 10kHz to 40kHz)

AC PARAMETERS vs TEMPERATURE
(f_{IN} = 1kHz, 0dB)

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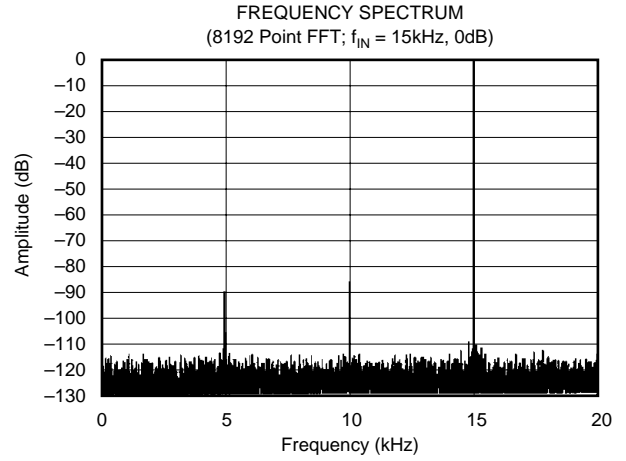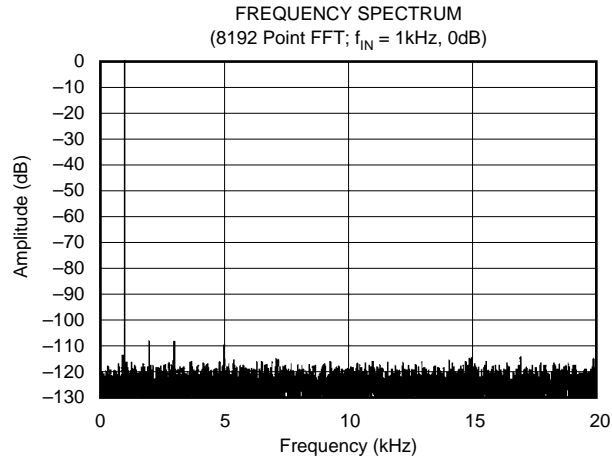
TYPICAL CHARACTERISTICS (Cont.)

At T_A = +25°C, f_S = 40kHz, V_{DIG} = V_{ANA} = +5V, and using internal reference and fixed resistors (see Figure 7b), unless otherwise specified.

All Codes INL

All Codes DNL

POWER-SUPPLY RIPPLE SENSITIVITY
INL/DNL DEGRADATION PER LSB OF P-P RIPPLE

INL

DNL

ENDPOINT ERRORS (20V Bipolar Range)

BPZ Error

+F_S Error

–F_S Error

ENDPOINT ERRORS (Unipolar Ranges)

UPO Error

+F_S Error (4V Range)

–F_S Error (5V Range)

INTERNAL REFERENCE VOLTAGE vs TEMPERATURE

CONVERSION TIME vs TEMPERATURE

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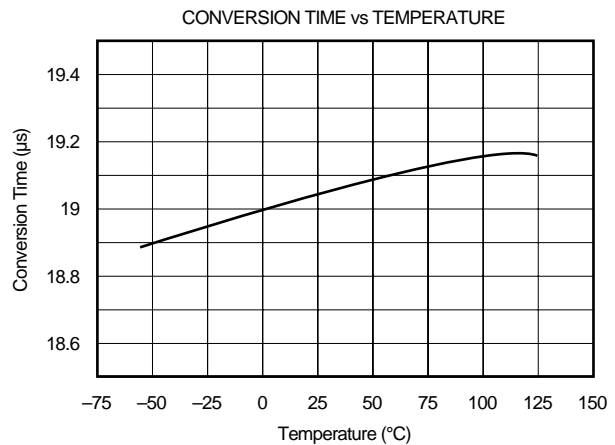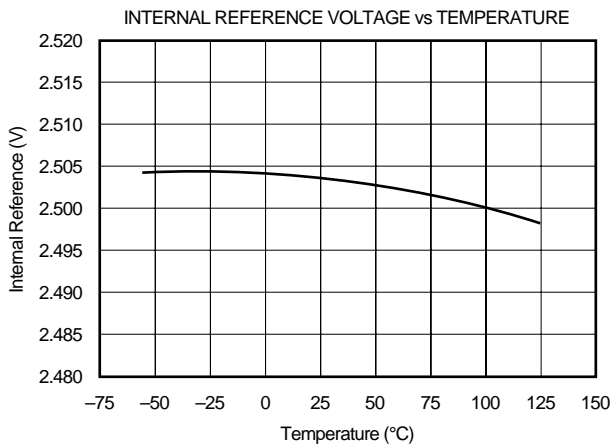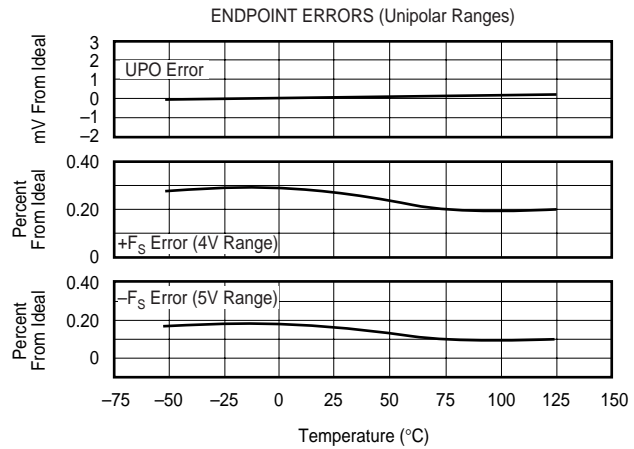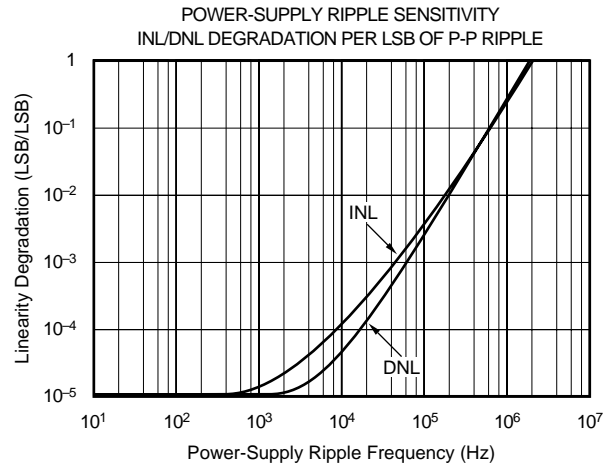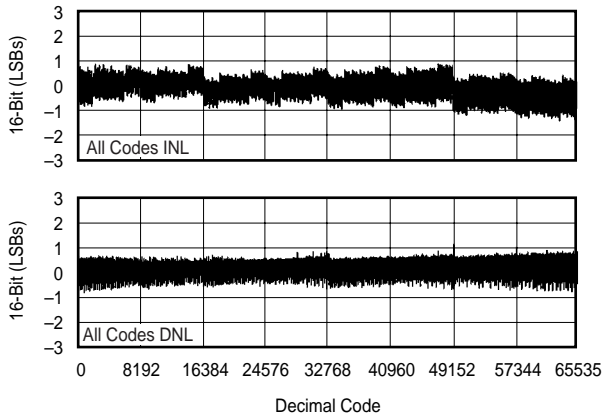
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BASIC OPERATION

PARALLEL OUTPUT

Figure 1a shows a basic circuit to operate the ADS7807 with a ±10V input range and parallel output. Taking R/$\overline{C}$ (pin 22) LOW for a minimum of 40ns (12µs max) will initiate a conversion. $\overline{BUSY}$ (pin 24) will go LOW and stay LOW until the conversion is completed and the output register is updated. If BYTE (pin 21) is LOW, the eight Most Significant Bits (MSBs) will be valid when $\overline{BUSY}$ rises; if BYTE is HIGH, the eight Least Significant Bits (LSBs) will be valid when $\overline{BUSY}$ rises. Data will be output in Binary Two's Complement (BTC) format. $\overline{BUSY}$ going HIGH can be used to latch the data. After the first byte has been read, BYTE can be toggled allowing the remaining byte to be read. All convert commands will be ignored while $\overline{BUSY}$ is LOW.

The ADS7807 will begin tracking the input signal at the end of the conversion. Allowing 25µs between convert commands assures accurate acquisition of a new signal.

The offset and gain are adjusted internally to allow external trimming with a single supply. The external resistors compensate for this adjustment and can be left out if the offset and gain will be corrected in software (refer to the Calibration section).

SERIAL OUTPUT

Figure 1b shows a basic circuit to operate the ADS7807 with a ±10V input range and serial output. Taking R/$\overline{C}$ (pin 22) LOW for 40ns (12µs max) will initiate a conversion and output valid data from the previous conversion on SDATA (pin 19) synchronized to 16 clock pulses output on DATACLK (pin 18). $\overline{BUSY}$ (pin 24) will go LOW and stay LOW until the conversion is completed and the serial data has been transmitted. Data will be output in BTC format, MSB first, and will be valid on both the rising and falling edges of the data clock. $\overline{BUSY}$ going HIGH can be used to latch the data. All convert commands will be ignored while $\overline{BUSY}$ is LOW.

The ADS7807 will begin tracking the input signal at the end of the conversion. Allowing 25µs between convert commands assures accurate acquisition of a new signal.

The offset and gain are adjusted internally to allow external trimming with a single supply. The external resistors compensate for this adjustment and can be left out if the offset and gain will be corrected in software (refer to the Calibration section).

STARTING A CONVERSION

The combination of $\overline{CS}$ (pin 23) and R/$\overline{C}$ (pin 22) LOW for a minimum of 40ns puts the sample-and-hold of the ADS7807 in the hold state and starts conversion 'n'. $\overline{BUSY}$ (pin 24) will go LOW and stay LOW until conversion 'n' is completed and the internal output register has been updated. All new convert commands during $\overline{BUSY}$ LOW will be ignored. $\overline{CS}$ and/ or R/$\overline{C}$ must go HIGH before $\overline{BUSY}$ goes HIGH, or a new conversion will be initiated without sufficient time to acquire a new signal.
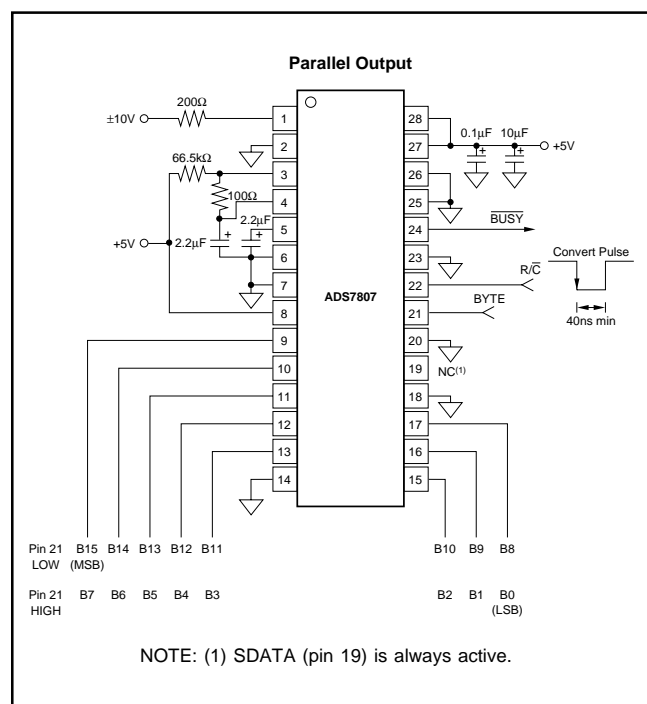

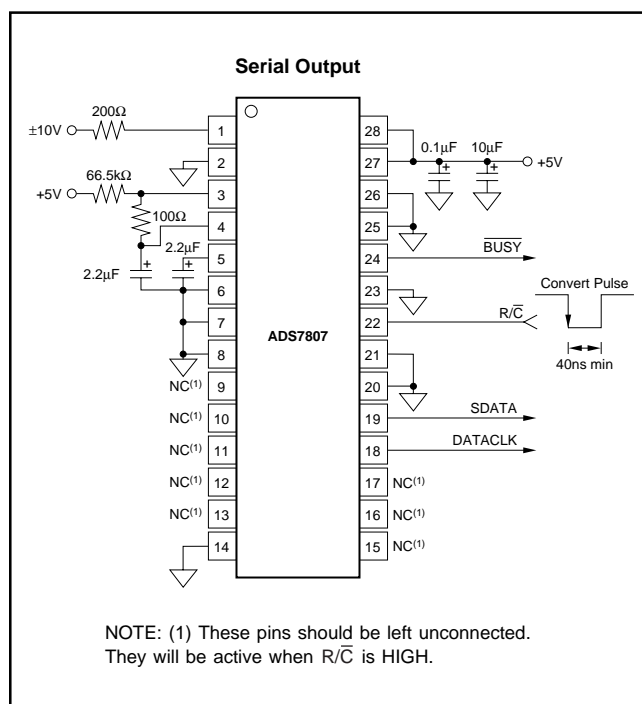FIGURE 1a. Basic ±10V Operation, both Parallel and Serial Output.

FIGURE 1b. Basic ±10V Operation with Serial Output.

The ADS7807 will begin tracking the input signal at the end of the conversion. Allowing 25µs between convert commands assures accurate acquisition of a new signal. Refer to Tables II and III for a summary of $\overline{CS}$, R/$\overline{C}$, and $\overline{BUSY}$ states, and Figures 2 through 6 for timing diagrams.

$\overline{CS}$ and R/$\overline{C}$ are internally OR'ed and level triggered. There is not a requirement which input goes LOW first when initiating a conversion. If, however, it is critical that $\overline{CS}$ or R/$\overline{C}$ initiates conversion 'n', be sure the less critical input is LOW at least 10ns prior to the initiating input. If EXT/$\overline{INT}$ (pin 8) is LOW when initiating conversion 'n', serial data from conversion 'n – 1' will be output on SDATA (pin 19) following the start of conversion 'n'. See Internal Data Clock in the Reading Data section.

To reduce the number of control pins, $\overline{CS}$ can be tied LOW using R/$\overline{C}$ to control the read and convert modes. This will have no effect when using the internal data clock in the serial output mode. The parallel output and the serial output (only when using an external data clock), however, will be affected whenever R/$\overline{C}$ goes HIGH. Refer to the Reading Data section.

READING DATA

The ADS7807 outputs serial or parallel data in Straight Binary (SB) or Binary Two's Complement data output format. If SB/$\overline{BTC}$ (pin 7) is HIGH, the output will be in SB format, and if LOW, the output will be in BTC format. Refer to Table IV for ideal output codes.

The parallel output can be read without affecting the internal output registers; however, reading the data through the serial port will shift the internal output registers one bit per data

$\overline{CS}$	R/$\overline{C}$	$\overline{BUSY}$	OPERATION
1	X	X	None. Databus is in Hi-Z state.
↓	0	1	Initiates conversion 'n'. Databus remains in Hi-Z state.
0	↓	1	Initiates conversion 'n'. Databus enters Hi-Z state.
0	1	↑	Conversion 'n' completed. Valid data from conversion 'n' on the databus.
↓	1	1	Enables databus with valid data from conversion 'n'.
↓	1	0	Enables databus with valid data from conversion 'n – 1'[1]. Conversion n in progress.
0	↑	0	Enables databus with valid data from conversion 'n – 1'[1]. Conversion 'n' in progress.
0	0	↑	New conversion initiated without acquisition of a new signal. Data will be invalid. $\overline{CS}$ and/or R/$\overline{C}$ must be HIGH when $\overline{BUSY}$ goes HIGH.
X	X	0	New convert commands ignored. Conversion 'n' in progress.

NOTE: (1) See Figures 2 and 3 for constraints on data valid from conversion 'n – 1'.

TABLE III. Control Functions When Using Parallel Output (DATACLK tied LOW, EXT/$\overline{INT}$ tied HIGH).

$\overline{CS}$	R/$\overline{C}$	$\overline{BUSY}$	EXT/$\overline{INT}$	DATACLK	OPERATION
↓	0	1	0	Output	Initiates conversion 'n'. Valid data from conversion 'n – 1' clocked out on SDATA.
0	↓	1	0	Output	Initiates conversion 'n'. Valid data from conversion 'n – 1' clocked out on SDATA.
↓	0	1	1	Input	Initiates conversion 'n'. Internal clock still runs conversion process.
0	↓	1	1	Input	Initiates conversion 'n'. Internal clock still runs conversion process.
↓	1	1	1	Input	Conversion 'n' completed. Valid data from conversion 'n' clocked out on SDATA synchronized to external data clock.
↓	1	0	1	Input	Valid data from conversion 'n – 1' output on SDATA synchronized to external data clock. Conversion 'n' in progress.
0	↑	0	1	Input	Valid data from conversion 'n – 1' output on SDATA synchronized to external data clock. Conversion 'n' in progress.
0	0	↑	X	X	New conversion initiated without acquisition of a new signal. Data will be invalid. $\overline{CS}$ and/or R/$\overline{C}$ must be HIGH when $\overline{BUSY}$ goes HIGH.
X	X	0	X	X	New convert commands ignored. Conversion 'n' in progress.

NOTE: (1) See Figures 4, 5, and 6 for constraints on data valid from conversion "n-1".

TABLE III. Control Functions When Using Serial Output.

DESCRIPTION	ANALOG INPUT			DIGITAL OUTPUT			
				BINARY TWO'S COMPLEMENT (SB/BTC LOW)		STRAIGHT BINARY (SB/BTC HIGH)	
Full-Scale Range	±10	0V to 5V	0V to 4V		HEX		HEX
Least Significant Bit (LSB)	305µV	76µV	61µV	BINARY CODE	CODE	BINARY CODE	CODE
+Full-Scale (FS – 1LSB)	9.999695V	4.999924V	3.999939V	0111 1111 1111 1111	7FFF	1111 1111 1111 1111	FFFF
Midscale	0V	2.5V	2V	0000 0000 0000 0000	0000	1000 0000 0000 0000	8000
One LSB Below Midscale	–305µV	2.499924V	1.999939V	1111 1111 1111 1111	FFFF	0111 1111 1111 1111	7FFF
–Full-Scale	–10V	0V	0V	1000 0000 0000 0000	8000	0000 0000 0000 0000	0000

TABLE IV. Output Codes and Ideal Input Voltages.

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clock pulse. As a result, data can be read on the parallel port prior to reading the same data on the serial port, but data cannot be read through the serial port prior to reading the same data on the parallel port.

PARALLEL OUTPUT

To use the parallel output, tie EXT/$\overline{\text{INT}}$ (pin 8) HIGH and DATACLK (pin 18) LOW. SDATA (pin 19) should be left unconnected. The parallel output will be active when R/$\overline{\text{C}}$ (pin 22) is HIGH and $\overline{\text{CS}}$ (pin 23) is LOW. Any other combination of $\overline{\text{CS}}$ and R/$\overline{\text{C}}$ will tri-state the parallel output. Valid conversion data can be read in two 8-bit bytes on D7-D0 (pins 9-13 and 15-17). When BYTE (pin 21) is LOW, the 8 most significant bits will be valid with the MSB on D7. When BYTE is HIGH, the 8 least significant bits will be valid with the LSB on D0. BYTE can be toggled to read both bytes within one conversion cycle.

Upon initial power up, the parallel output will contain indeterminate data.

PARALLEL OUTPUT (AFTER A CONVERSION)

After conversion 'n' is completed and the output registers have been updated, $\overline{\text{BUSY}}$ (pin 24) will go HIGH. Valid data from conversion 'n' will be available on D7-D0 (pins 9-13 and 15-17). $\overline{\text{BUSY}}$ going high can be used to latch the data. Refer to Table V and Figures 2 and 3 for timing constraints.

PARALLEL OUTPUT (DURING A CONVERSION)

After conversion 'n' has been initiated, valid data from conversion 'n – 1' can be read and will be valid up to 12µs after the start of conversion 'n'. Do not attempt to read data beyond 12µs after the start of conversion 'n' until $\overline{\text{BUSY}}$ (pin 24) goes HIGH; this may result in reading invalid data. Refer to Table V and Figures 2 and 3 for timing constraints.
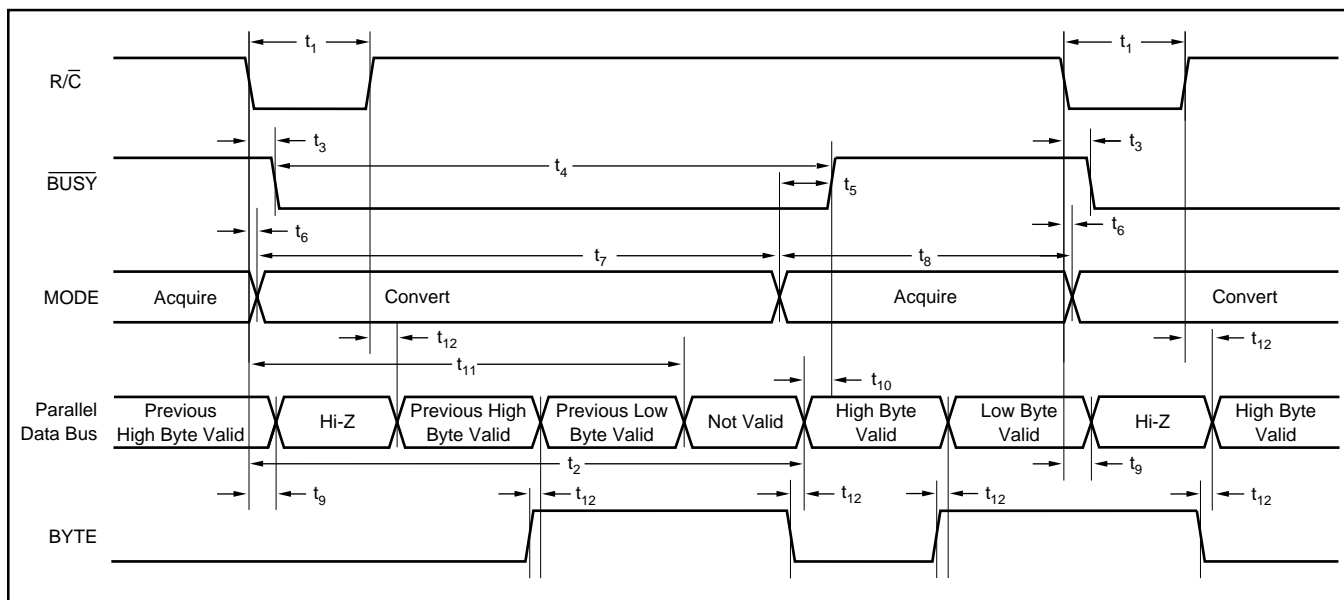

FIGURE 2. Conversion Timing with Parallel Output ($\overline{\text{CS}}$ and DATACLK tied LOW, EXT/$\overline{\text{INT}}$ tied HIGH).
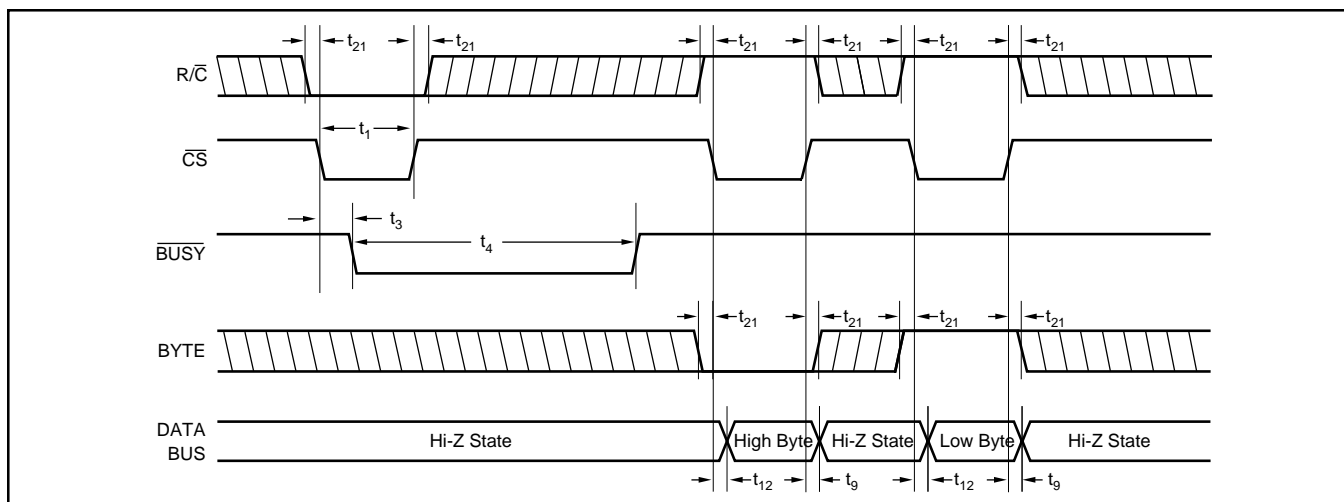

FIGURE 3. Using $\overline{\text{CS}}$ to Control Conversion and Read Timing with Parallel Outputs.

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SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNITS
t_1	Convert Pulse Width	0.04		12	µs
t_2	Data Valid Delay after R/$\overline{\text{C}}$ LOW		19	20	µs
t_3	$\overline{\text{BUSY}}$ Delay from Start of Conversion			85	ns
t_4	$\overline{\text{BUSY}}$ LOW		19	20	µs
t_5	$\overline{\text{BUSY}}$ Delay after End of Conversion		90		ns
t_6	Aperture Delay		40		ns
t_7	Conversion Time		19	20	µs
t_8	Acquisition Time			5	µs
t_9	Bus Relinquish Time	10		83	ns
t_{10}	$\overline{\text{BUSY}}$ Delay after Data Valid	20	60		ns
t_{11}	Previous Data Valid after Start of Conversion	12	19		µs
t_{12}	Bus Access Time and BYTE Delay			83	ns
t_{13}	Start of Conversion to DATACLK Delay		1.4		µs
t_{14}	DATACLK Period		1.1		µs
t_{15}	Data Valid to DATACLK HIGH Delay	20	75		ns
t_{16}	Data Valid after DATACLK LOW Delay	400	600		ns
t_{17}	External DATACLK Period	100			ns
t_{18}	External DATACLK LOW	40			ns
t_{19}	External DATACLK HIGH	50			ns
t_{20}	$\overline{\text{CS}}$ and R/$\overline{\text{C}}$ to External DATACLK Setup Time	25			ns
t_{21}	R/$\overline{\text{C}}$ to $\overline{\text{CS}}$ Setup Time	10			ns
t_{22}	Valid Data after DATACLK HIGH	25			ns
$t_7 + t_8$	Throughput Time			25	µs

TABLE VI. Conversion and Data Timing. $T_A = -40°C$ to $+85°C$.

SERIAL OUTPUT

Data can be clocked out with the internal data clock or an external data clock. When using serial output, be careful with the parallel outputs, D7-D0 (pins 9-13 and 15-17), as these pins will come out of Hi-Z state whenever $\overline{\text{CS}}$ (pin 23) is LOW and R/$\overline{\text{C}}$ (pin 22) is HIGH. The serial output can not be tri-stated and is always active. Refer to the Applications Information section for specific serial interfaces.

INTERNAL DATA CLOCK
(During a Conversion)

To use the internal data clock, tie EXT/$\overline{\text{INT}}$ (pin 8) LOW. The combination of R/$\overline{\text{C}}$ (pin 22) and $\overline{\text{CS}}$ (pin 23) LOW will initiate conversion 'n' and activate the internal data clock (typically 900kHz clock rate). The ADS7807 will output 16 bits of valid data, MSB first, from conversion 'n-1' on SDATA (pin 19), synchronized to 16 clock pulses output on DATACLK (pin 18). The data will be valid on both the rising and falling edges of the internal data clock. The rising edge of $\overline{\text{BUSY}}$ (pin 24) can be used to latch the data. After the 16th clock pulse, DATACLK will remain LOW until the next conversion is initiated, while SDATA will go to whatever logic level was input on TAG (pin 20) during the first clock pulse. Refer to Table VI and Figure 4.

EXTERNAL DATA CLOCK

To use an external data clock, tie EXT/$\overline{\text{INT}}$ (pin 8) HIGH. The external data clock is not a conversion clock; it can only be used as a data clock. To enable the output mode of the ADS7807, $\overline{\text{CS}}$ (pin 23) must be LOW and R/$\overline{\text{C}}$ (pin 22) must be HIGH. DATACLK must be HIGH for 20% to 70% of the total data clock period; the clock rate can be between DC and 10MHz. Serial data from conversion 'n' can be output on SDATA (pin 19) after conversion 'n' is completed or during conversion 'n + 1'.

An obvious way to simplify control of the converter is to tie $\overline{\text{CS}}$ LOW and use R/$\overline{\text{C}}$ to initiate conversions.

While this is perfectly acceptable, there is a possible problem when using an external data clock. At an indeterminate point from 12µs after the start of conversion 'n' until $\overline{\text{BUSY}}$ rises, the internal logic will shift the results of conversion 'n' into the output register. If $\overline{\text{CS}}$ is LOW, R/$\overline{\text{C}}$ HIGH, and the external clock is HIGH at this point, data will be lost. So, with $\overline{\text{CS}}$ LOW, either R/$\overline{\text{C}}$ and/or DATACLK must be LOW during this period to avoid losing valid data.
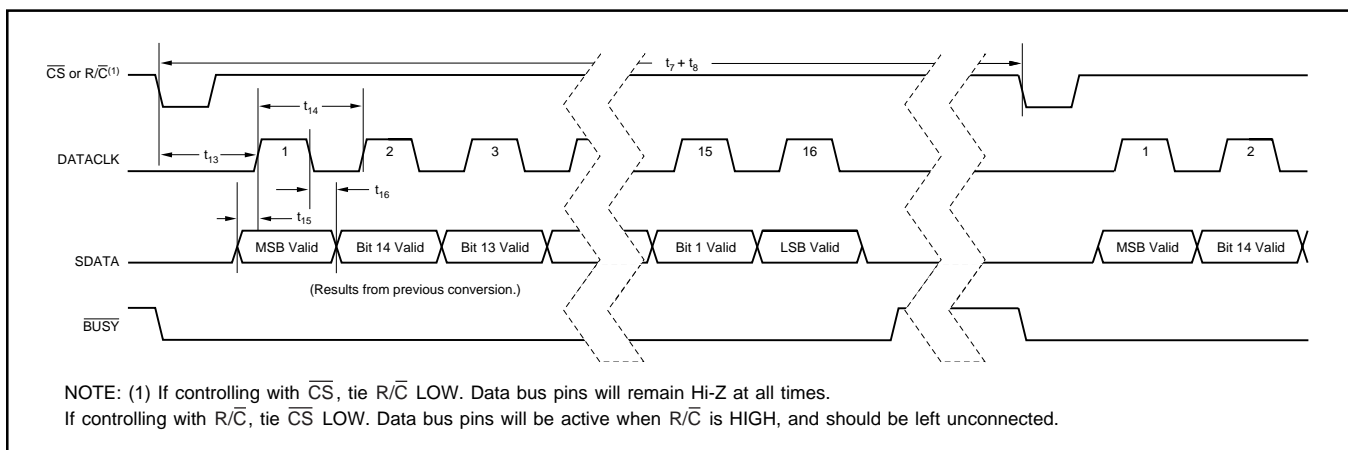

NOTE: (1) If controlling with $\overline{\text{CS}}$, tie R/$\overline{\text{C}}$ LOW. Data bus pins will remain Hi-Z at all times.
If controlling with R/$\overline{\text{C}}$, tie $\overline{\text{CS}}$ LOW. Data bus pins will be active when R/$\overline{\text{C}}$ is HIGH, and should be left unconnected.

FIGURE 4. Serial Data Timing Using Internal Data Clock (TAG tied LOW).

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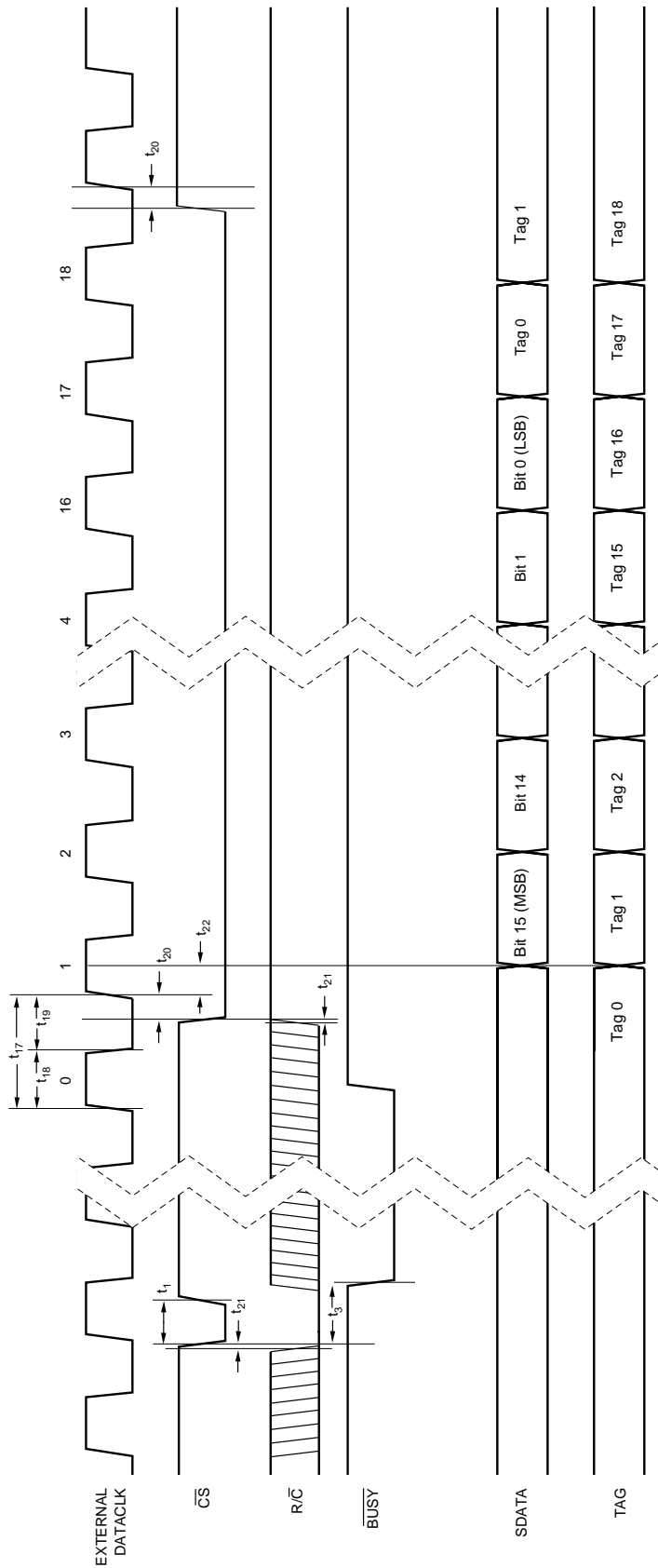
FIGURE 5. Conversion and Read Timing with External Clock (EXT/$\overline{\text{INT}}$ Tied HIGH) Read after Conversion.

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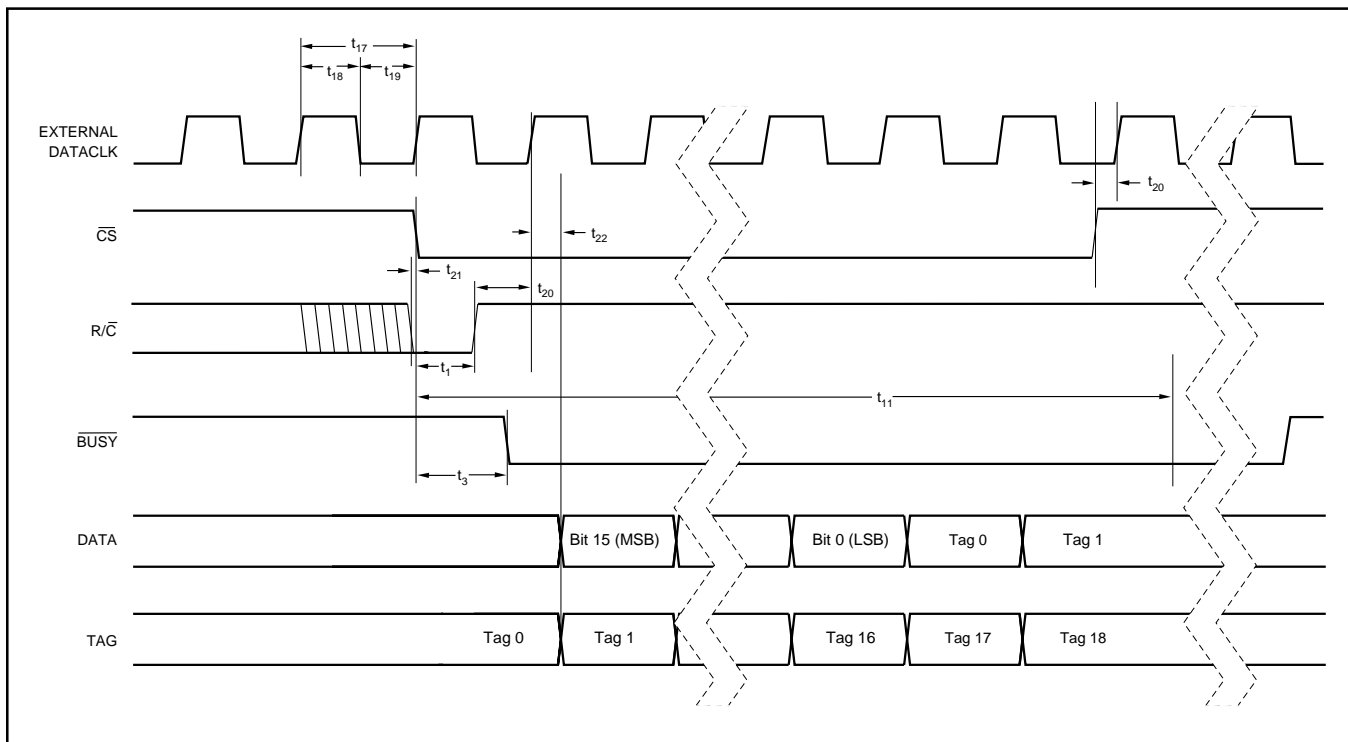
FIGURE 6. Conversion and Read Timing with External Clock ($\overline{\text{EXT}/\text{INT}}$ tied HIGH) Read During a Conversion.

EXTERNAL DATA CLOCK
(After a Conversion)

After conversion 'n' is completed and the output registers have been updated, $\overline{\text{BUSY}}$ (pin 24) will go HIGH. With $\overline{\text{CS}}$ LOW and R/$\overline{\text{C}}$ HIGH, valid data from conversion 'n' will be output on SDATA (pin 19) synchronized to the external data clock input on DATACLK (pin 18). The MSB will be valid on the first falling edge and the second rising edge of the external data clock. The LSB will be valid on the 16th falling edge and 17th rising edge of the data clock. TAG (pin 20) will input a bit of data for every external clock pulse. The first bit input on TAG will be valid on SDATA on the 17th falling edge and the 18th rising edge of DATACLK; the second input bit will be valid on the 18th falling edge and the 19th rising edge, etc. With a continuous data clock, TAG data will be output on SDATA until the internal output registers are updated with the results from the next conversion. Refer to Table VI and Figure 5.

EXTERNAL DATA CLOCK
(During a Conversion)

After conversion 'n' has been initiated, valid data from conversion 'n – 1' can be read and will be valid up to 12μs after the start of conversion 'n'. Do not attempt to clock out data from 12μs after the start of conversion 'n' until $\overline{\text{BUSY}}$ (pin 24) rises; this will result in data loss. NOTE: For the best possible performance when using an external data clock, data should not be clocked out during a conversion. The switching noise of the asynchronous data clock can cause digital feedthrough degrading the converter's performance. Refer to Table V and Figure 6.

TAG FEATURE

TAG (pin 20) inputs serial data synchronized to the external or internal data clock.

When using an external data clock, the serial bit stream input on TAG will follow the LSB output on SDATA until the internal output register is updated with new conversion results. See Table V and Figures 5 and 6.

The logic level input on TAG for the first rising edge of the internal data clock will be valid on SDATA after all 16 bits of valid data have been output.

INPUT RANGES

The ADS7807 offers three input ranges: standard ±10V and 0V-5V, and a 0V-4V range for complete, single-supply systems. See Figures 7a and 7b for the necessary circuit connections for implementing each input range and optional offset and gain adjust circuitry. Offset and full-scale error[1] specifications are tested with the fixed resistors, see Figure 7b. Adjustments for offset and gain are described in the Calibration section of this data sheet.

The offset and gain are adjusted internally to allow external trimming with a single supply. The external resistors compensate for this adjustment and can be left out if the offset and gain will be corrected in software (refer to the Calibration section).

The input impedance, summarized in Table II, results from the combination of the internal resistor network (see the front page of this product data sheet) and the external resistors

NOTE: (1) Full-scale error includes offset and gain errors measured at both +FS and −FS.

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used for each input range (see Figure 8). The input resistor divider network provides inherent over-voltage protection to at least ±5.5V for $R2_{IN}$ and ±12V for $R1_{IN}$.

Analog inputs above or below the expected range will yield either positive full-scale or negative full-scale digital outputs, respectively. Wrapping or folding over for analog inputs outside the nominal range will not occur.

CALIBRATION

HARDWARE CALIBRATION

To calibrate the offset and gain of the ADS7807 in hardware, install the resistors shown in Figure 7a. Table VI lists the hardware trim ranges relative to the input for each input range.

SOFTWARE CALIBRATION

To calibrate the offset and gain in software, no external resistors are required. However, to get the data sheet specifications for offset and gain, the resistors shown in Figure 7b

INPUT RANGE	OFFSET ADJUST RANGE (mV)	GAIN ADJUST RANGE (mV)
±10V	±15	±60
0 to 5V	±4	±30
0 to 4V	±3	±30

TABLE VI. Offset and Gain Adjust Ranges for Hardware Calibration (see Figure 7a).

are necessary. See the No Calibration section for more details on the external resistors. Refer to Table VIII for the range of offset and gain errors with and without the external resistors.

NO CALIBRATION

Figure 7b shows circuit connections. Note that the actual voltage dropped across the external resistors is at least two orders of magnitude lower than the voltage dropped across the internal resistor divider network. This should be consid-
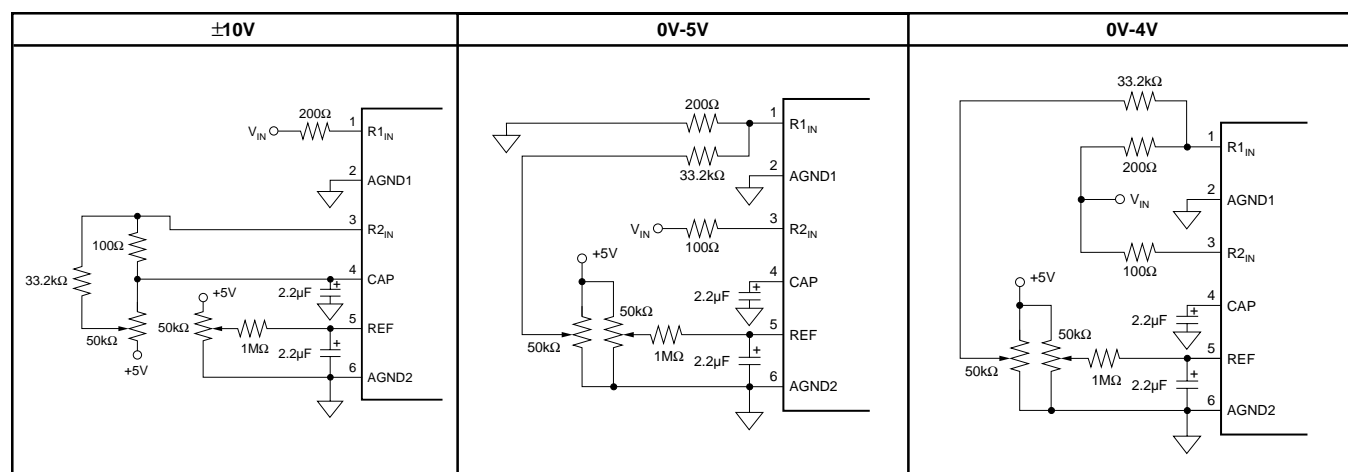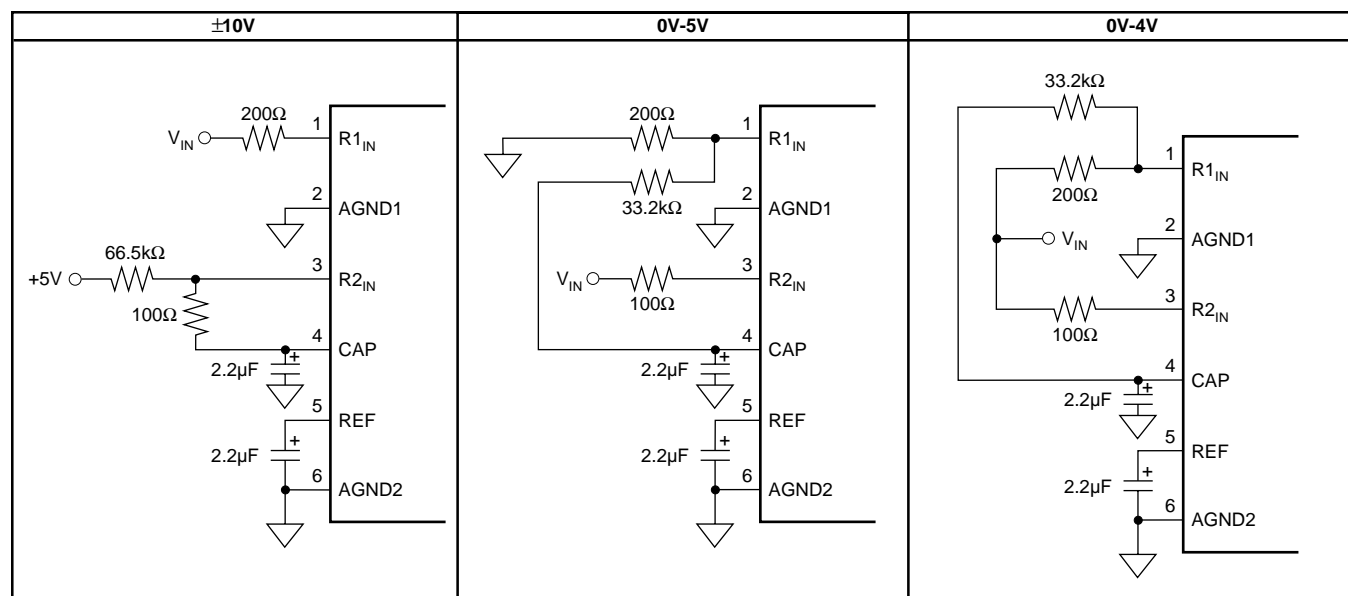

FIGURE 7a. Circuit Diagrams (With Hardware Trim).

FIGURE 7b. Circuit Diagrams (Without Hardware Trim).

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ered when choosing the accuracy and drift specifications of the external resistors. In most applications, 1% metal-film resistors will be sufficient.

The external resistors, see Figure 7b, may not be necessary in some applications. These resistors provide compensation for an internal adjustment of the offset and gain which allows calibration with a single supply. Not using the external resistors will result in offset and gain errors in addition to those listed in the electrical characteristics section. Offset refers to the equivalent voltage of the digital output when converting with the input grounded. A positive gain error occurs when the equivalent output voltage of the digital output is larger than the analog input. Refer to Table VII for nominal ranges of gain and offset errors with and without the external resistors. Refer to Figure 8 for typical shifts in the transfer functions which occur when the external resistors are removed.

To further analyze the effects of removing any combination of the external resistors, consider Figure 9. The combination of the external and the internal resistors form a voltage divider which reduces the input signal to a 0.3125V to 2.8125V input range at the Capacitor Digital-to-Analog Converter (CDAC). The internal resistors are laser trimmed to high relative accuracy to meet full scale specifications. The actual input impedance of the internal resistor network looking into pin 1 or pin 3 however, is only accurate to ±20% due to process variations. This should be taken into account when determining the effects of removing the external resistors.

REFERENCE

The ADS7807 can operate with its internal 2.5V reference or an external reference. By applying an external reference to pin 5, the internal reference can be bypassed; REFD (pin 26)

INPUT RANGE (V)	OFFSET ERROR				GAIN ERROR		
	WITH RESISTORS	WITHOUT RESISTORS			WITH RESISTORS	WITHOUT RESISTORS	
	RANGE (mV)	RANGE (mV)		TYP (mV)	RANGE (% FS)	RANGE (% FS)	TYP
±10	−10 ≤ BPZ ≤ 10	0 ≤ BPZ ≤ 35		15	−0.4 ≤ G ≤ 0.4 0.15 ≤ G$^{(1)}$ ≤ 0.15	−0.3 ≤ G ≤ 0.5 −0.1 ≤ G$^{(1)}$ ≤ 0.2	+0.05 +0.05
0 to 5	−3 ≤ UPO ≤ 3	−12 ≤ UPO ≤ −3		−7.5	−0.4 ≤ G ≤ 0.4 0.15 ≤ G$^{(1)}$ ≤ 0.15	−1.0 ≤ G ≤ 0.1 −0.55 ≤ G$^{(1)}$ ≤ −0.05	−0.2 −0.2
0 to 4	−3 ≤ UPO ≤ 3	−10.5 ≤ UPO ≤ −1.5		−6	−0.4 ≤ G ≤ 0.4 −0.15 ≤ G$^{(1)}$ ≤ 0.15	−1.0 ≤ G ≤ 0.1 −0.55 ≤ G$^{(1)}$ ≤ −0.05	−0.2 −0.2
NOTE: (1) High Grade.							

TABLE VII. Range of Offset and Gain Errors With and Without External Resistors.
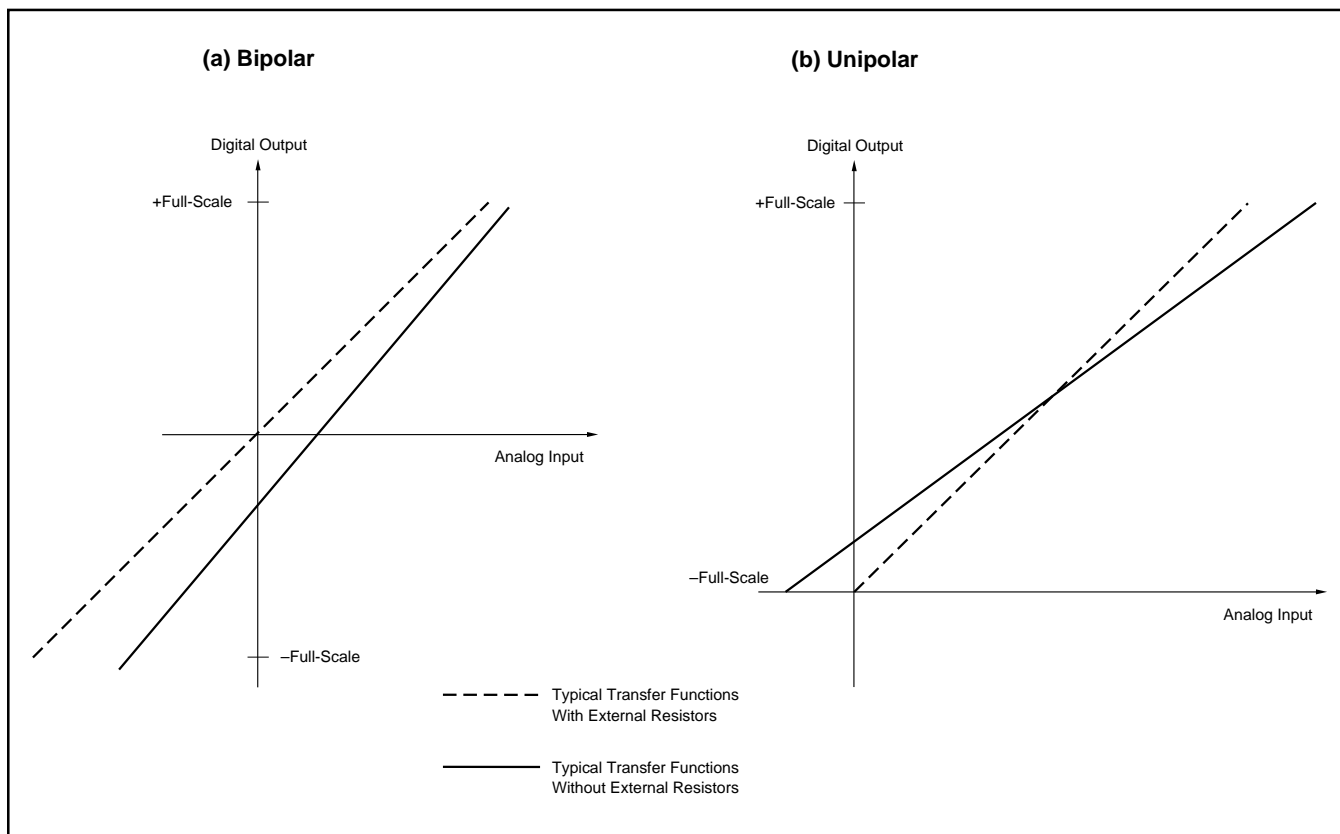
FIGURE 8. Typical Transfer Functions With and Without External Resistors.

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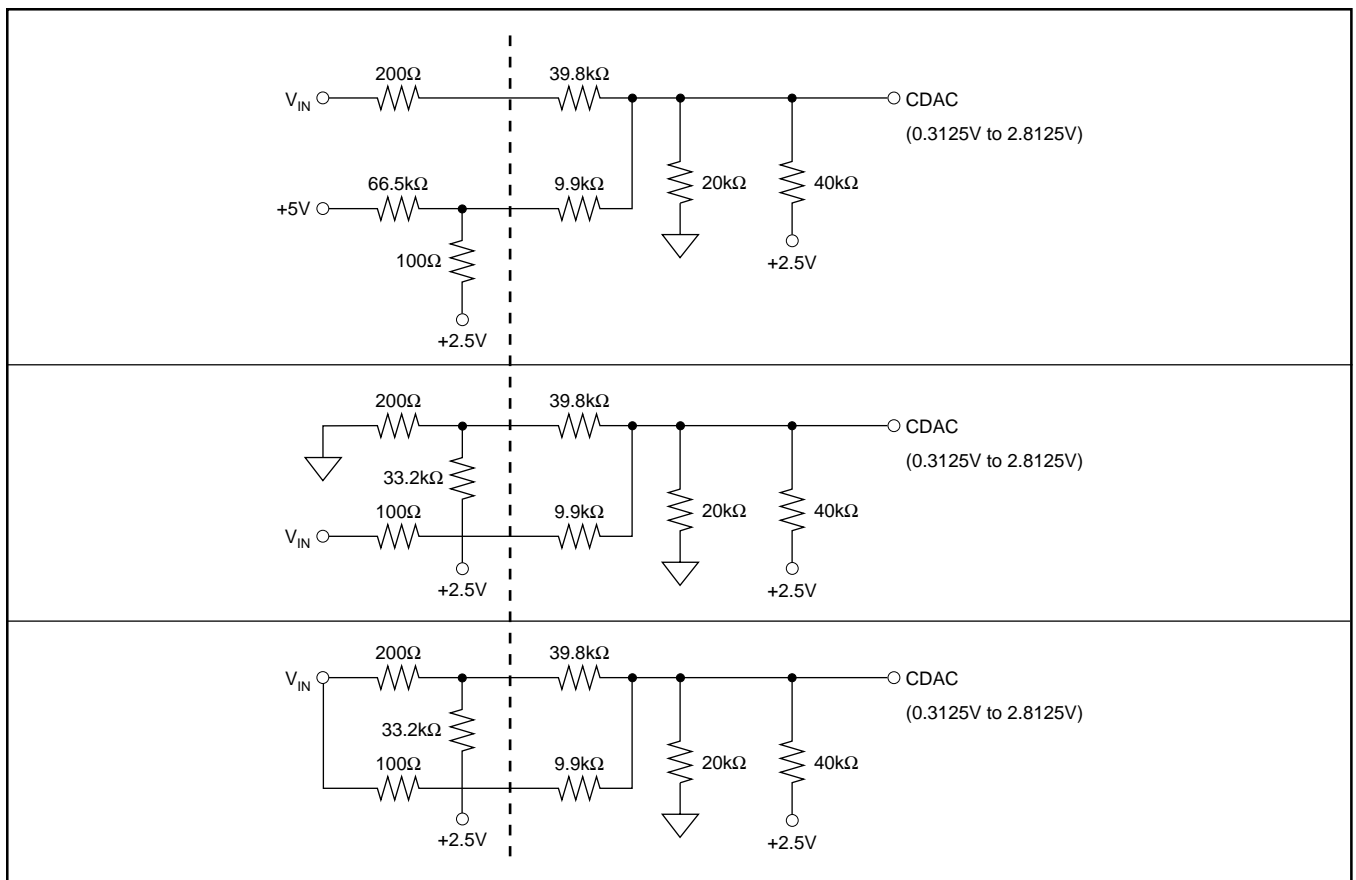www.ti.com

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FIGURE 9. Circuit Diagrams Showing External and Internal Resistors.

tied HIGH will power-down the internal reference reducing the overall power consumption of the ADS7807 by approximately 5mW.

The internal reference has approximately an 8ppm/°C drift (typical) and accounts for approximately 20% of the full-scale error (FSE = ±0.5% for low grade, ±0.25% for high grade).

The ADS7807 also has an internal buffer for the reference voltage. Figure 10 shows characteristic impedances at the input and output of the buffer with all combinations of power-down and reference down.

REF

REF (pin 5) is an input for an external reference or the output for the internal 2.5V reference. A 2.2μF tantalum capacitor should be connected as close as possible to the REF pin from ground. This capacitor and the output resistance of REF create a low-pass filter to bandlimit noise on the reference. Using a smaller value capacitor will introduce more noise to the reference, degrading the SNR and SINAD. The REF pin should not be used to drive external AC or DC loads, as shown in Figure 10.

The range for the external reference is 2.3V to 2.7V and determines the actual LSB size. Increasing the reference voltage will increase the full-scale range and the LSB size of the converter which can improve the SNR.
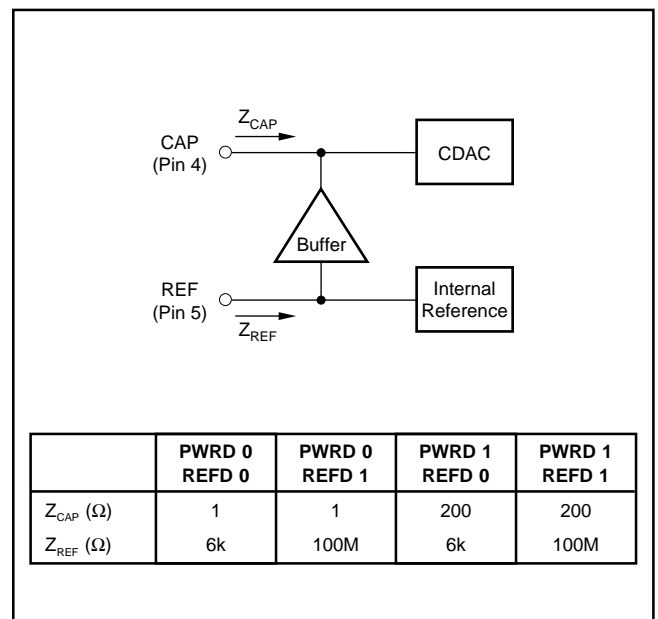

FIGURE 10. Characteristic Impedances of Internal Buffer.

	PWRD 0 REFD 0	PWRD 0 REFD 1	PWRD 1 REFD 0	PWRD 1 REFD 1
Z_{CAP} (Ω)	1	1	200	200
Z_{REF} (Ω)	6k	100M	6k	100M

CAP

CAP (pin 4) is the output of the internal reference buffer. A 2.2μF tantalum capacitor should be placed as close as possible to the CAP pin from ground to provide optimum switching currents for the CDAC throughout the conversion

cycle. This capacitor also provides compensation for the output of the buffer. Using a capacitor any smaller than 1µF can cause the output buffer to oscillate and may not have sufficient charge for the CDAC. Capacitor values larger than 2.2µF will have little affect on improving performance. See Figures 10 and 11.
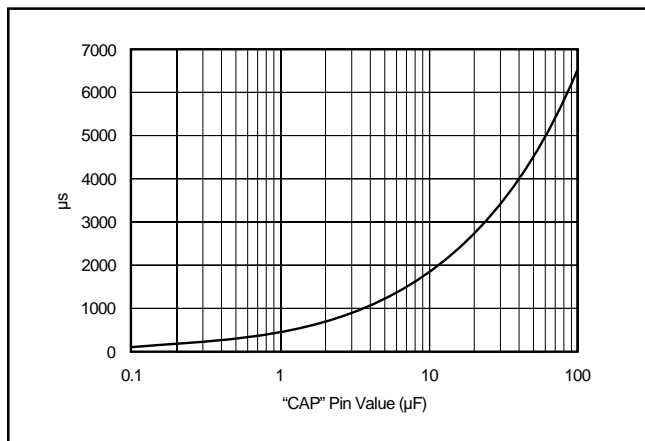

FIGURE 11. Power-Down to Power-Up Time vs Capacitor Value on CAP.

The output of the buffer is capable of driving up to 1mA of current to a DC load. Using an external buffer will allow the internal reference to be used for larger DC loads and AC loads. Do not attempt to directly drive an AC load with the output voltage on CAP. This will cause performance degradation of the converter.

REFERENCE AND POWER-DOWN

The ADS7807 has analog power-down and reference power down capabilities via PWRD (pin 25) and REFD (pin 26), respectively. PWRD and REFD HIGH will power-down all analog circuitry maintaining data from the previous conversion in the internal registers, provided that the data has not already been shifted out through the serial port. Typical power consumption in this mode is 50µW. Power recovery is typically 1ms, using a 2.2µF capacitor connected to CAP. Figure 11 shows power-down to power-up recovery time relative to the capacitor value on CAP. With +5V applied to V_{DIG}, the digital circuitry of the ADS7807 remains active at all times, regardless of PWRD and REFD states.

PWRD

PWRD HIGH will power-down all of the analog circuitry except for the reference. Data from the previous conversion will be maintained in the internal registers and can still be read. With PWRD HIGH, a convert command yields meaningless data.

REFD

REFD HIGH will power-down the internal 2.5V reference. All other analog circuitry, including the reference buffer, will be active. REFD should be HIGH when using an external reference to minimize power consumption and the loading effects on the external reference. See Figure 10 for the characteristic impedance of the reference buffer's input for both REFD HIGH and LOW. The internal reference consumes approximately 5mW.

LAYOUT

POWER

For optimum performance, tie the analog and digital power pins to the same +5V power supply and tie the analog and digital grounds together. As noted in the electrical characteristics, the ADS7807 uses 90% of its power for the analog circuitry. The ADS7807 should be considered as an analog component.

The +5V power for the A/D converter should be separate from the +5V used for the system's digital logic. Connecting V_{DIG} (pin 28) directly to a digital supply can reduce converter performance due to switching noise from the digital logic. For best performance, the +5V supply can be produced from whatever analog supply is used for the rest of the analog signal conditioning. If +12V or +15V supplies are present, a simple +5V regulator can be used. Although it is not suggested, if the digital supply must be used to power the converter, be sure to properly filter the supply. Either using a filtered digital supply or a regulated analog supply, both V_{DIG} and V_{ANA} should be tied to the same +5V source.

GROUNDING

Three ground pins are present on the ADS7807. D_{GND} is the digital supply ground. A_{GND2} is the analog supply ground. A_{GND1} is the ground to which all analog signals internal to the A/D converter are referenced. A_{GND1} is more susceptible to current induced voltage drops and must have the path of least resistance back to the power supply.

All the ground pins of the A/D converter should be tied to an analog ground plane, separated from the system's digital logic ground, to achieve optimum performance. Both analog and digital ground planes should be tied to the "system" ground as near to the power supplies as possible. This helps to prevent dynamic digital ground currents from modulating the analog ground through a common impedance to power ground.

SIGNAL CONDITIONING

The FET switches used for the sample hold on many CMOS A/D converters release a significant amount of charge injection which can cause the driving op amp to oscillate. The

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amount of charge injection due to the sampling FET switch on the ADS7807 is approximately 5% to 10% of the amount on similar A/D converters with the charge redistribution Digital-to-Analog Converter (DAC) CDAC architecture. There is also a resistive front end which attenuates any charge which is released. The end result is a minimal requirement for the drive capability on the signal conditioning preceding the A/D converter. Any op amp sufficient for the signal in an application will be sufficient to drive the ADS7807.

The resistive front end of the ADS7807 also provides a specified ±25V over-voltage protection. In most cases, this eliminates the need for external over-voltage protection circuitry.

INTERMEDIATE LATCHES

The ADS7807 does have tri-state outputs for the parallel port, but intermediate latches should be used if the bus will be active during conversions. If the bus is not active during conversion, the tri-state outputs can be used to isolate the A/D converter from other peripherals on the same bus.

Intermediate latches are beneficial on any monolithic A/D converter. The ADS7807 has an internal LSB size of 38μV. Transients from fast switching signals on the parallel port, even when the A/D converter is tri-stated, can be coupled through the substrate to the analog circuitry causing degradation of converter performance.

APPLICATIONS INFORMATION

TRANSITION NOISE

Apply a DC input to the ADS7807 and initiate 1000 conversions. The digital output of the converter will vary in output codes due to the internal noise of the ADS7807. This is true for all 16-bit SAR converters. The transition noise specification found in the electrical characteristics section is a statistical figure which represents the one sigma limit or rms value of these output codes.

Using a histogram to plot the output codes, the distribution should appear bell-shaped with the peak of the bell curve representing the nominal output code for the input voltage value. The ±1σ, ±2σ, and ±3σ distributions will represent 68.3%, 95.5%, and 99.7% of all codes. Multiplying TN by 6 will yield the ±3σ distribution or 99.7% of all codes. Statistically, up to 3 codes could fall outside the 5 code distribution when executing 1000 conversions. The ADS7807 has a TN of 0.8LSBs which yields 5 output codes for a ±3σ distribution. Figures 12 and 13 show 1000 and 10000 conversion histogram results.

AVERAGING

The noise of the converter can be compensated by averaging the digital codes. By averaging conversion results, transition noise will be reduced by a factor of $1/\sqrt{Hz}$ where n is
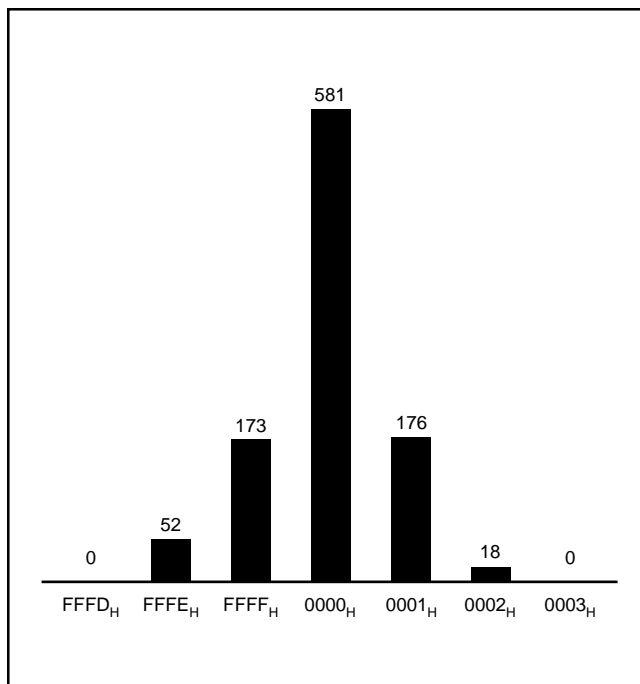

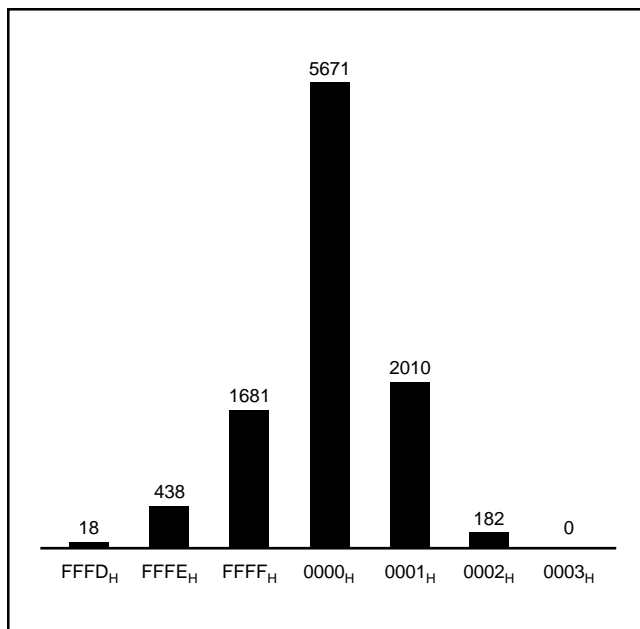FIGURE 12. Histogram of 1000 Conversions with Input Grounded.

FIGURE 13. Histogram of 10000 Conversions with Input Grounded.

the number of averages. For example, averaging four conversion results will reduce the TN by 1/2 to 0.4LSBs. Averaging should only be used for input signals with frequencies near DC.

For AC signals, a digital filter can be used to low-pass filter and decimate the output codes. This works in a similar manner to averaging: for every decimation by 2, the signal-to-noise ratio will improve 3dB.

QSPI™ INTERFACING

Figure 14 shows a simple interface between the ADS7807 and any QSPI equipped microcontroller. This interface assumes that the convert pulse does not originate from the microcontroller and that the ADS7807 is the only serial peripheral.

Before enabling the QSPI interface, the microcontroller must be configured to monitor the slave select line. When a transition from LOW to HIGH occurs on Slave Select ($\overline{SS}$) from $\overline{BUSY}$ (indicating the end of the current conversion), the port can be enabled. If this is not done, the microcontroller and the A/D converter may be "out-of-sync".
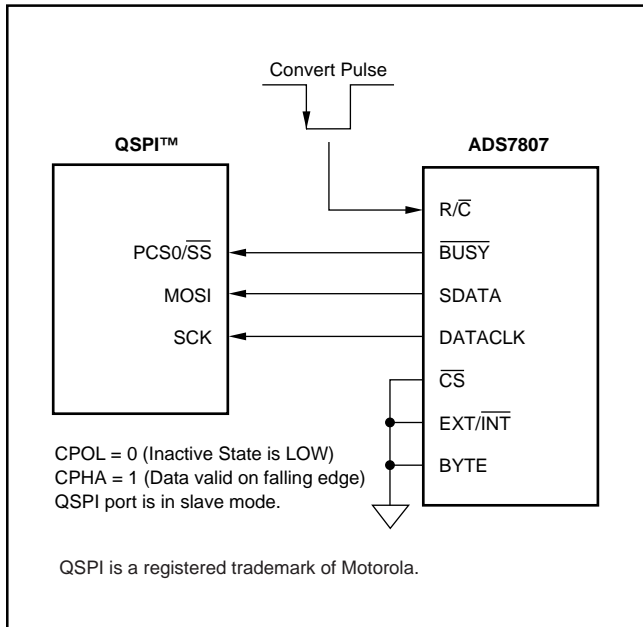

FIGURE 14. QSPI Interface to the ADS7807.

Figure 15 shows another interface between the ADS7807 and a QSPI equipped microcontroller which allows the microcontroller to give the convert pulses while also allowing multiple peripherals to be connected to the serial bus. This interface and the following discussion assume a master clock for the QSPI interface of 16.78MHz. Notice that the serial data input of the microcontroller is tied to the MSB (D7) of the ADS7807 instead of the serial output (SDATA). Using D7 instead of the serial port offers tri-state capability which allows other peripherals to be connected to the MISO pin. When communication is desired with those peripherals, PCS0 and PCS1 should be left HIGH; that will keep D7 tri-stated.

In this configuration, the QSPI interface is actually set to do two different serial transfers. The first, an 8-bit transfer, causes PCS0 (R/$\overline{C}$) and PCS1 ($\overline{CS}$) to go LOW, starting a conversion. The second, a 16-bit transfer, causes only PCS1 ($\overline{CS}$) to go LOW. This is when the valid data will be transferred.

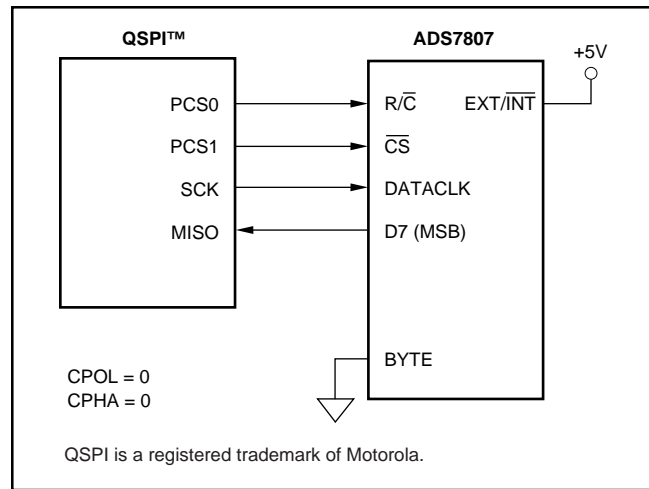QSPI is a registered trademark of Motorola.

FIGURE 15. QSPI Interface to the ADS7807. Processor Initiates Conversions.

For both transfers, the DT register (delay after transfer) is used to cause a 19μs delay. The interface is also set up to wrap to the beginning of the queue. In this manner, the QSPI is a state machine which generates the appropriate timing for the ADS7807. This timing is thus locked to the crystal-based timing of the microcontroller and not interrupt driven. So, this interface is appropriate for both AC and DC measurements.

For the fastest conversion rate, the baud rate should be set to 2 (4.19MHz SCK), DT set to 10, the first serial transfer set to 8 bits, the second set to 16 bits, and DSCK disabled (in the command control byte). This will allow for a 23kHz maximum conversion rate. For slower rates, DT should be increased. Do not slow SCK as this may increase the chance of affecting the conversion results or accidently initiating a second conversion during the first 8-bit transfer.

In addition, CPOL and CPHA should be set to zero (SCK normally LOW and data captured on the rising edge). The command control byte for the 8-bit transfer should be set to 20_H and for the 16-bit transfer to 61_H.

SPI™ INTERFACE

The SPI interface is generally only capable of 8-bit data transfers. For some microcontrollers with SPI interfaces, it might be possible to receive data in a similar manner as shown for the QSPI interface in Figure 14. The microcontroller will need to fetch the 8 most significant bits before the contents are overwritten by the least significant bits.

A modified version of the QSPI interface shown in Figure 15 might be possible. For most microcontrollers with SPI interface, the automatic generation of the start-of-conversion pulse will be impossible and will have to be done with software. This will limit the interface to 'DC' applications due to the insufficient jitter performance of the convert pulse itself.

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ADS7807
SBAS022B

DSP56000 INTERFACING

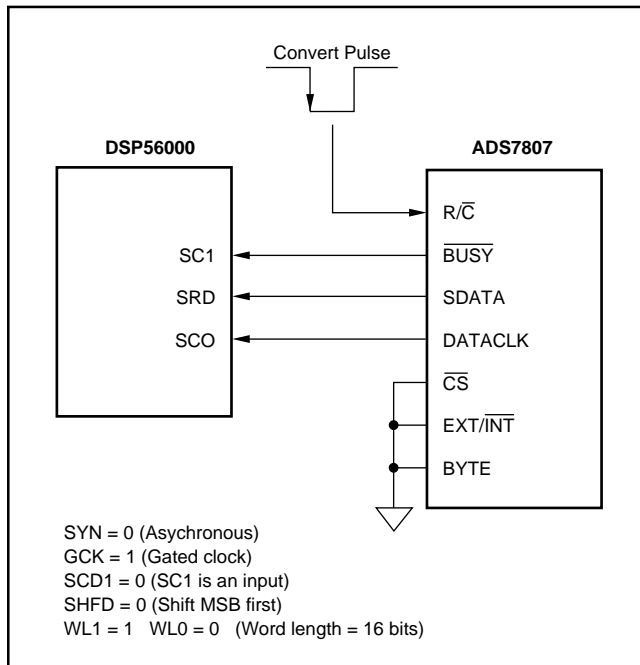The DSP56000 serial interface has SPI compatibility mode with some enhancements. Figure 16 shows an interface between the ADS7807 and the DSP56000 which is very similar to the QSPI interface seen in Figure 14. As mentioned in the QSPI section, the DSP56000 must be programmed to enable the interface when a LOW to HIGH transition on SC1 is observed ($\overline{BUSY}$ going HIGH at the end of conversion).

The DSP56000 can also provide the convert pulse by including a monostable multi-vibrator, as seen in Figure 17. The receive and transmit sections of the interface are decoupled (asynchronous mode) and the transmit section is set to generate a word length frame sync every other transmit frame (frame rate divider set to 2). The prescale modulus should be set to 3.

The monostable multi-vibrator in this circuit will provide varying pulse widths for the convert pulse. The pulse width will be determined by the external R and C values used with the multi-vibrator. The 74HCT123N data sheet shows that the pulse width is (0.7) RC. Choosing a pulse width as close to the minimum value specified in this data sheet will offer the best performance. See the Starting A Conversion section of this data sheet for details on the conversion pulse width.

The maximum conversion rate for a 20.48MHz DSP56000 is exactly 40kHz. Note that this will not be the case for the ADS7806. See the ADS7806 data sheet (SBAS021A) for more information.
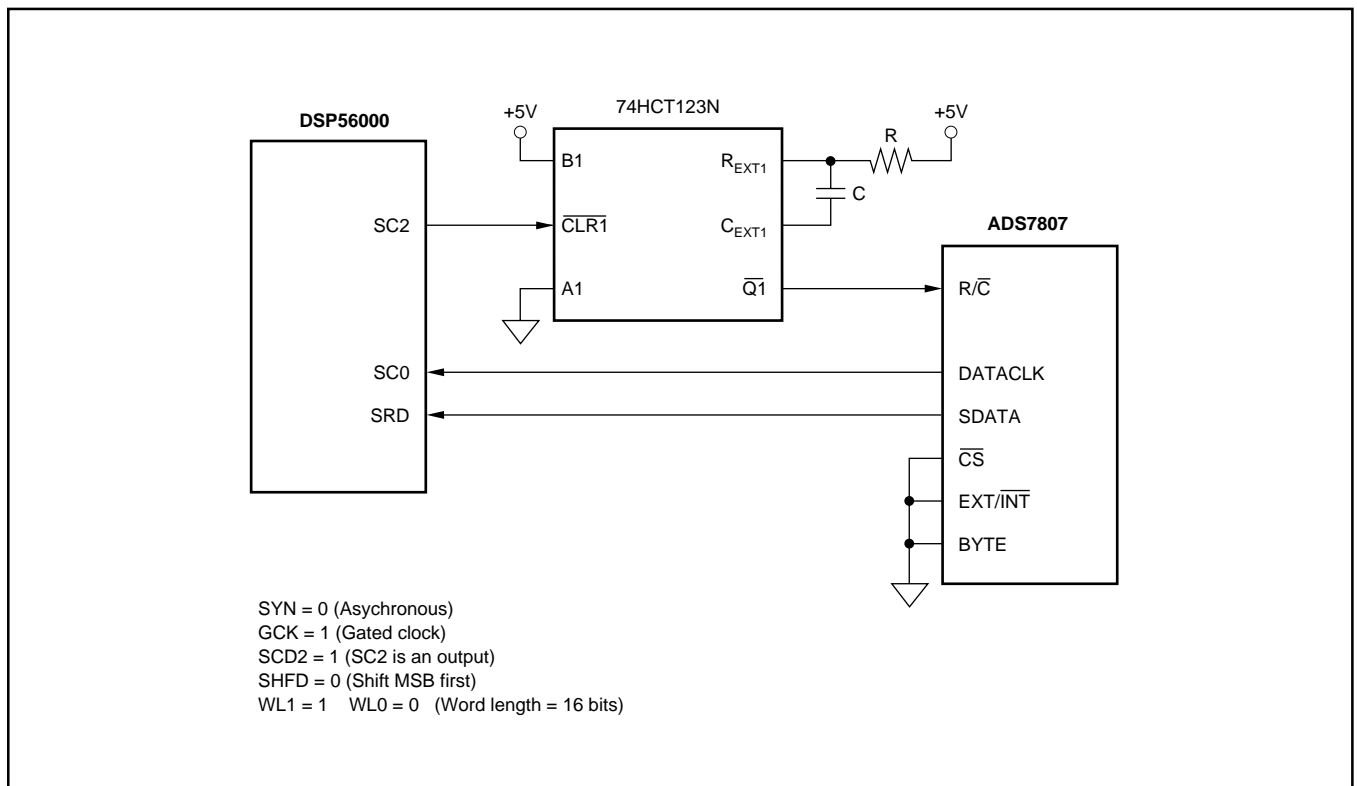

FIGURE 16. DSP56000 Interface to the ADS7807.

FIGURE 17. DSP56000 Interface to the ADS7807. Processor Initiates Conversions.

PACKAGING INFORMATION

ORDERABLE DEVICE	STATUS(1)	PACKAGE TYPE	PACKAGE DRAWING	PINS	PACKAGE QTY
ADS7807P	ACTIVE	PDIP	NT	28	13
ADS7807PB	ACTIVE	PDIP	NT	28	13
ADS7807U	ACTIVE	SOIC	DW	28	28
ADS7807U/1K	ACTIVE	SOIC	DW	28	1000
ADS7807UB	ACTIVE	SOIC	DW	28	28
ADS7807UB/1K	ACTIVE	SOIC	DW	28	1000

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

MECHANICAL DATA

MPDI004 – OCTOBER 1994

NT (R-PDIP-T**)   **PLASTIC DUAL-IN-LINE PACKAGE**

24 PINS SHOWN
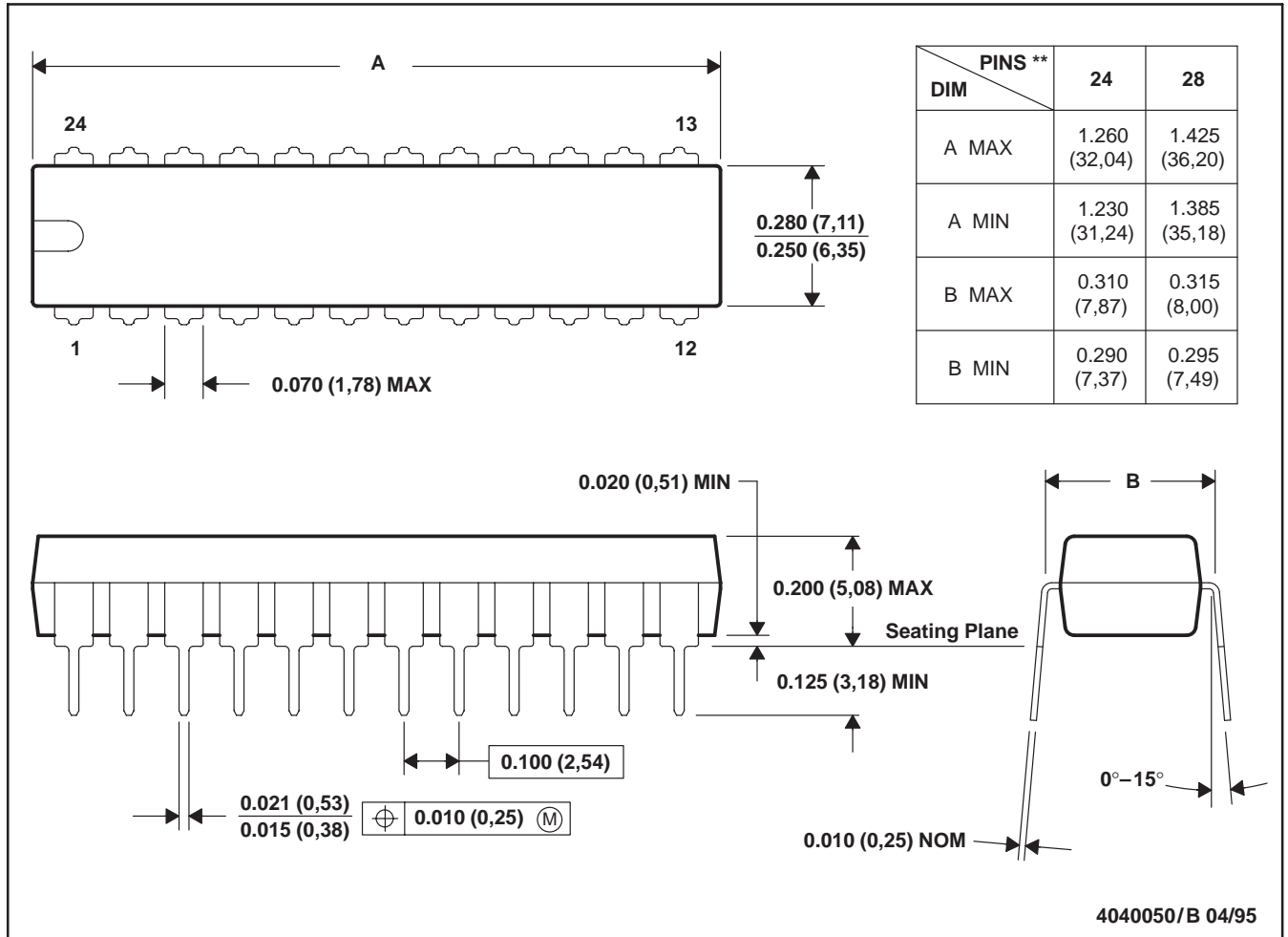
PINS ** DIM	24	28
A MAX	1.260 (32,04)	1.425 (36,20)
A MIN	1.230 (31,24)	1.385 (35,18)
B MAX	0.310 (7,87)	0.315 (8,00)
B MIN	0.290 (7,37)	0.295 (7,49)

0.070 (1,78) MAX

0.280 (7,11) / 0.250 (6,35)

0.020 (0,51) MIN

0.200 (5,08) MAX

Seating Plane

0.125 (3,18) MIN

0.100 (2,54)

0.021 (0,53) / 0.015 (0,38) ⊕ 0.010 (0,25) Ⓜ

0°–15°

0.010 (0,25) NOM

4040050/B 04/95

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.

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1

DW (R-PDSO-G**) 　　　　　　　　　　　　　　　　　**PLASTIC SMALL-OUTLINE PACKAGE**

16 PINS SHOWN

0.050 (1,27)

0.020 (0,51)
0.014 (0,35)

⊕ 0.010 (0,25) Ⓜ

16　　　　　　9

0.419 (10,65)
0.400 (10,15)

0.299 (7,59)
0.291 (7,39)

0.010 (0,25) NOM

Gage Plane

0.010 (0,25)

0°– 8°

0.050 (1,27)
0.016 (0,40)

1　　　　　　8

A

0.104 (2,65) MAX

0.012 (0,30)
0.004 (0,10)

Seating Plane

⌒ 0.004 (0,10)

DIM ＼ PINS **	16	18	20	24	28
A MAX	0.410 (10,41)	0.462 (11,73)	0.510 (12,95)	0.610 (15,49)	0.710 (18,03)
A MIN	0.400 (10,16)	0.453 (11,51)	0.500 (12,70)	0.600 (15,24)	0.700 (17,78)

4040000/E 08/01
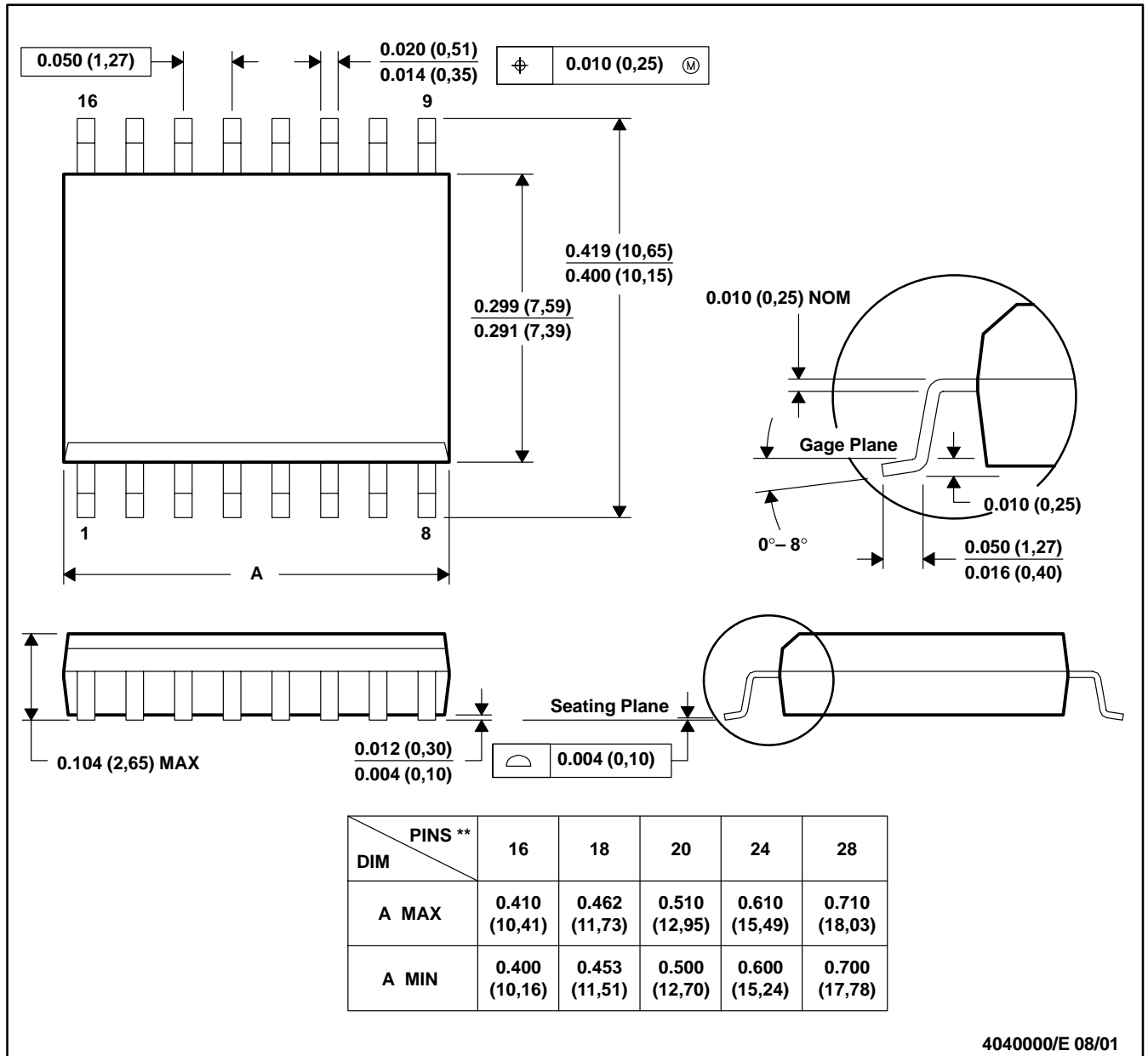
NOTES: A. All linear dimensions are in inches (millimeters).
　　　　B. This drawing is subject to change without notice.
　　　　C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
　　　　D. Falls within JEDEC MS-013

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Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

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